

# LPC1102/1104

32-bit ARM Cortex-M0 microcontroller; 32 kB flash and 8 kB SRAM

Rev. 7 — 26 September 2013

Product data sheet

## 1. General description

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The LPC1102/1104 are an ARM Cortex-M0 based, low-cost 32-bit MCU, designed for 8/16-bit microcontroller applications, offering performance, low power, simple instruction set and memory addressing together with reduced code size compared to existing 8/16-bit architectures.

The LPC1102/1104 operate at CPU frequencies of up to 50 MHz.

The peripheral complement of the LPC1102/1104 includes 32 kB of flash memory, 8 kB of data memory, one RS-485/EIA-485 UART, one SPI interface with SSP features, four general purpose counter/timers, a 10-bit ADC, and 11 general purpose I/O pins.

**Remark:** The LPC1104 has a revised pinout and contains several features not found in the LPC1102:

- Two extra GPIO pins (PIO0\_1 and PIO0\_6).
- Extra match output (CT32B0\_MAT2).
- CLKOUT feature.
- Easier re-entry to ISP via PIO0\_1.
- SSP0\_CLK available on two pins (A1 and A2) to support debugging of SSP communication.
- Better positioning of the XTALIN pin for easier PCB layout.

## 2. Features and benefits

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- System:
  - ◆ ARM Cortex-M0 processor, running at frequencies of up to 50 MHz.
  - ◆ ARM Cortex-M0 built-in Nested Vectored Interrupt Controller (NVIC).
  - ◆ Serial Wire Debug.
  - ◆ System tick timer.
- Memory:
  - ◆ 32 kB on-chip flash programming memory.
  - ◆ 8 kB SRAM.
  - ◆ In-Application Programming (IAP) and In-System Programming (ISP) support via on-chip bootloader software.
- Digital peripherals:
  - ◆ 11 General Purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors and programmable open-drain mode.



- ◆ GPIO pins can be used as edge and level sensitive interrupt sources.
- ◆ Four general purpose counter/timers with a total of one capture input and 10 match outputs.
- ◆ Programmable windowed WatchDog Timer (WDT).
- Analog peripherals:
  - ◆ 10-bit ADC with input multiplexing among five pins.
- Serial interfaces:
  - ◆ UART with fractional baud rate generation, internal FIFO, and RS-485 support.
  - ◆ One SPI controller with SSP features and with FIFO and multi-protocol capabilities (see [Section 7.16](#)).
- Clock generation:
  - ◆ 12 MHz internal RC oscillator trimmed to 1 % accuracy that can optionally be used as a system clock.
  - ◆ Programmable watchdog oscillator with a frequency range of 9.4 kHz to 2.3 MHz.
  - ◆ PLL allows CPU operation up to the maximum CPU rate without the need for a high-frequency crystal. May be run from an external clock or the internal RC oscillator.
  - ◆ Clock output function with divider that can reflect the system oscillator clock, IRC clock, CPU clock, and the Watchdog clock (LPC1104 only).
- Power control:
  - ◆ Integrated PMU (Power Management Unit) to minimize power consumption during Sleep and Deep-sleep modes.
  - ◆ Power profiles residing in boot ROM allowing to optimize performance and minimize power consumption for any given application through one simple function call.
  - ◆ Two reduced power modes: Sleep and Deep-sleep modes.
  - ◆ Processor wake-up from Deep-sleep mode via a dedicated start logic using up to six of the functional pins.
  - ◆ Power-On Reset (POR).
  - ◆ Brownout detect with up to four separate thresholds for interrupt and forced reset.
- Unique device serial number for identification.
- Single 3.3 V power supply (1.8 V to 3.6 V).
- Available as WLCSP16 package.

### 3. Applications

- Mobile devices
- Consumer peripherals
- Lighting
- 8-/16-bit applications
- Portable devices

## 4. Ordering information

Table 1. Ordering information

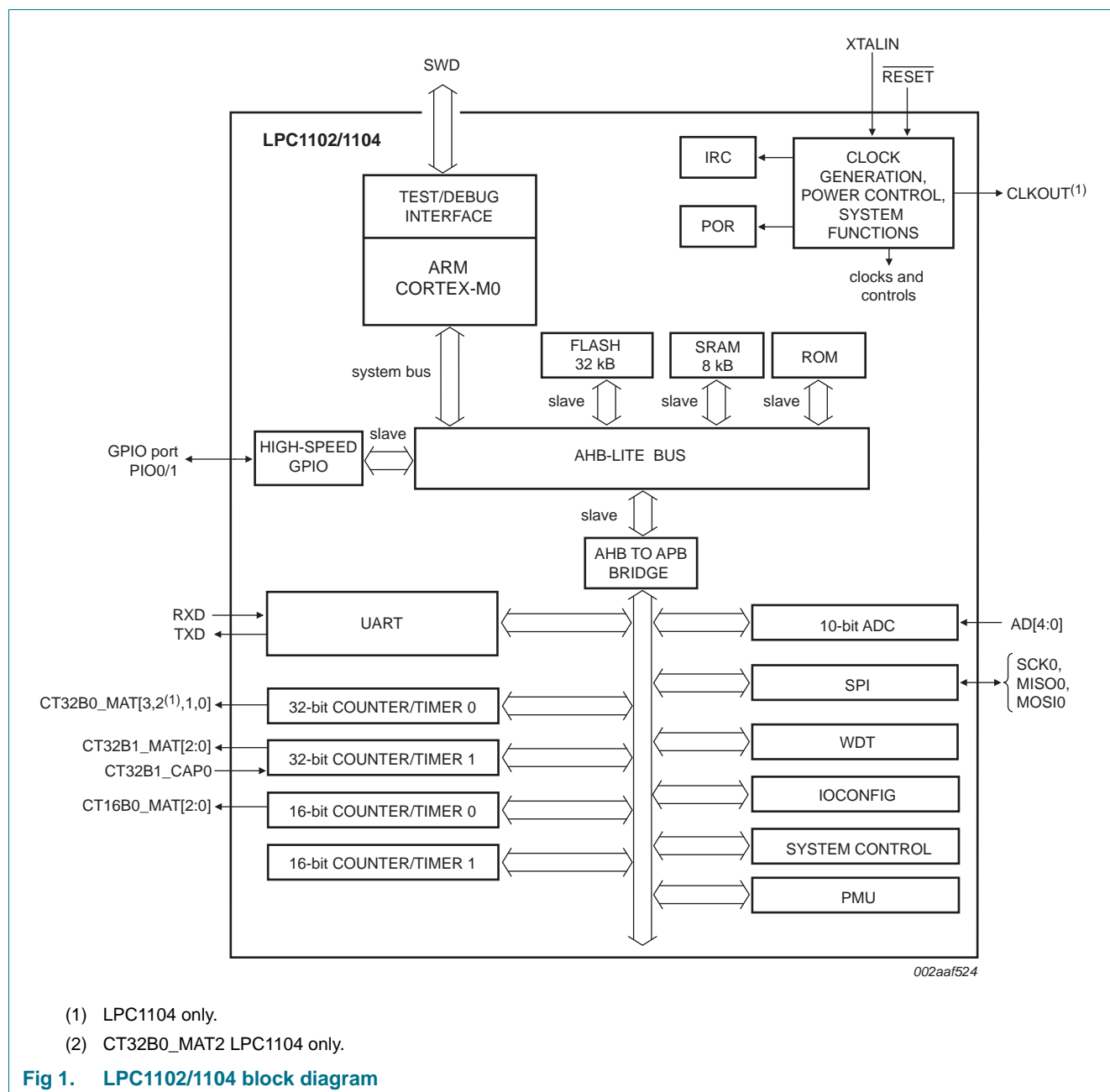
Type number	Package		
	Name	Description	Version
LPC1102UK	WLCSP16	wafer level chip-size package; 16 bumps; 2.17 × 2.32 × 0.6 mm	-
LPC1104UK	WLCSP16	wafer level chip-size package; 16 bumps; 2.17 × 2.32 × 0.6 mm	-

### 4.1 Ordering options

Table 2. Ordering options

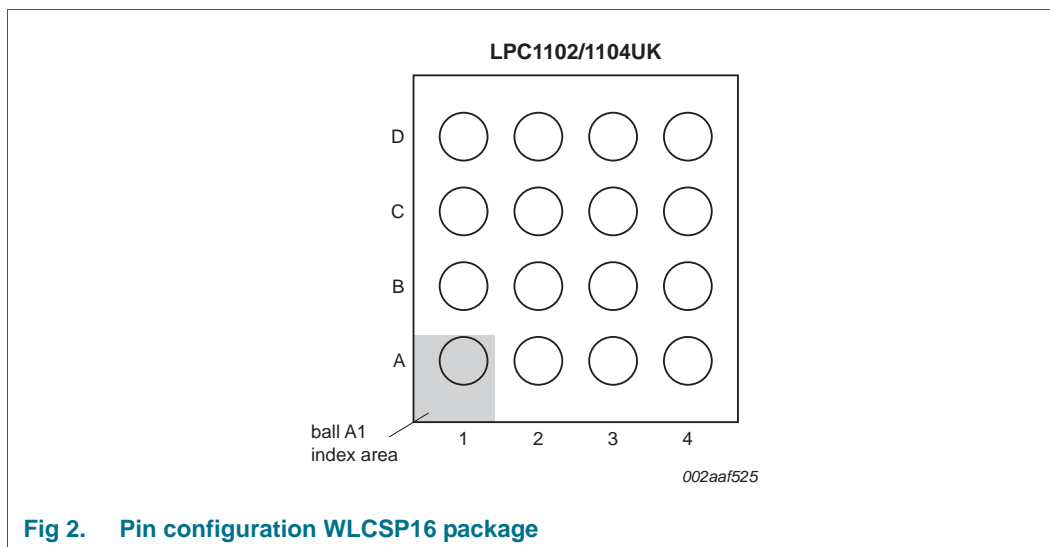
Type number	Flash	Total SRAM	UART RS-485	SPI	ADC channels	Package
LPC1102UK	32 kB	8 kB	1	1	5	WLCSP16
LPC1104UK	32 kB	8 kB	1	1	5	WLCSP16

## 5. Block diagram



## 6. Pinning information

### 6.1 Pinning



## 6.2 Pin description

**Table 3.** LPC1102/1104 pin description table

Symbol	LPC1102	LPC1104	Start logic input	Type	Reset state <sup>[1]</sup>	Description
RESET/PIO0_0	C1 <sup>[2]</sup>	B2 <sup>[2]</sup>	yes	I	I; PU	<b>RESET</b> — External reset input with 20 ns glitch filter. A LOW -going pulse as short as 50 ns on this pin resets the device, causing I/O ports and peripherals to take on their default states, and processor execution to begin at address 0.
PIO0_1/CLKOUT/ CT32B0_MAT2	-	C1 <sup>[3]</sup>	yes	I/O	-	<b>PIO0_0</b> — General purpose digital input/output pin.
				I/O	I; PU	<b>PIO0_1</b> — General purpose digital input/output pin. A LOW level on this pin during reset starts the ISP command handler.
				O	-	<b>CLKOUT</b> — Clockout pin.
PIO0_6/SCK0	-	A1 <sup>[3]</sup>	yes	O	-	<b>CT32B0_MAT2</b> — Match output 2 for 32-bit timer 0.
				I/O	I;PU	<b>PIO0_6</b> — General purpose digital input/output pin.
PIO0_8/MISO/ CT16B0_MAT0	A2 <sup>[3]</sup>	A3 <sup>[3]</sup>	yes	I/O	-	<b>SCK0</b> — Serial clock for SPI0.
				I/O	I; PU	<b>PIO0_8</b> — General purpose digital input/output pin.
				I/O	-	<b>MISO0</b> — Master In Slave Out for SPI.
PIO0_9/MOSI/ CT16B0_MAT1	A3 <sup>[3]</sup>	A4 <sup>[3]</sup>	yes	O	-	<b>CT16B0_MAT0</b> — Match output 0 for 16-bit timer 0.
				I/O	I; PU	<b>PIO0_9</b> — General purpose digital input/output pin.
				I/O	-	<b>MOSI0</b> — Master Out Slave In for SPI.
SWCLK/ PIO0_10/ SCK0/CT16B0_MAT2	A4 <sup>[3]</sup>	A2 <sup>[3]</sup>	yes	O	-	<b>CT16B0_MAT1</b> — Match output 1 for 16-bit timer 0.
				I	I; PU	<b>SWCLK</b> — Serial wire clock.
				I/O	-	<b>PIO0_10</b> — General purpose digital input/output pin.
				I/O	-	<b>SCK0</b> — Serial clock for SPI0.
R/PIO0_11/ AD0/CT32B0_MAT3	B4 <sup>[4]</sup>	B4 <sup>[4]</sup>	yes	O	-	<b>CT16B0_MAT2</b> — Match output 2 for 16-bit timer 0.
				-	I; PU	<b>R</b> — Reserved.
				I/O	-	<b>PIO0_11</b> — General purpose digital input/output pin.
				I	-	<b>AD0</b> — A/D converter, input 0.
R/PIO1_0/ AD1/CT32B1_CAP0	B3 <sup>[4]</sup>	B3 <sup>[4]</sup>	yes	I	-	<b>CT32B0_MAT3</b> — Match output 3 for 32-bit timer 0.
				-	I; PU	<b>R</b> — Reserved.
				I/O	-	<b>PIO1_0</b> — General purpose digital input/output pin.
				I	-	<b>AD1</b> — A/D converter, input 1.
R/PIO1_1/ AD2/CT32B1_MAT0	C4 <sup>[4]</sup>	C4 <sup>[4]</sup>	no	I	-	<b>CT32B1_CAP0</b> — Capture input 0 for 32-bit timer 1.
				-	I; PU	<b>R</b> — Reserved.
				I/O	-	<b>PIO1_1</b> — General purpose digital input/output pin.
				I	-	<b>AD2</b> — A/D converter, input 2.
				O	-	<b>CT32B1_MAT0</b> — Match output 0 for 32-bit timer 1.

Table 3. LPC1102/1104 pin description table ...continued

Symbol	LPC1102	LPC1104	Start logic input	Type	Reset state <sup>[1]</sup>	Description
R/PIO1_2/ AD3/CT32B1_MAT1	C3 <sup>[4]</sup>	C3 <sup>[4]</sup>	no	-	I; PU	R — Reserved.
				I/O	-	PIO1_2 — General purpose digital input/output pin.
				I	-	AD3 — A/D converter, input 3.
				O	-	CT32B1_MAT1 — Match output 1 for 32-bit timer 1.
SWDIO/PIO1_3/AD4/ CT32B1_MAT2	D4 <sup>[4]</sup>	D4 <sup>[4]</sup>	no	I/O	I; PU	SWDIO — Serial wire debug input/output.
				I/O	-	PIO1_3 — General purpose digital input/output pin.
				I	-	AD4 — A/D converter, input 4.
				O	-	CT32B1_MAT2 — Match output 2 for 32-bit timer 1.
PIO1_6/RXD/ CT32B0_MAT0	C2 <sup>[3]</sup>	C2 <sup>[3]</sup>	no	I/O	I; PU	PIO1_6 — General purpose digital input/output pin.
				I	-	RXD — Receiver input for UART.
				O	-	CT32B0_MAT0 — Match output 0 for 32-bit timer 0.
				O	-	CT32B0_MAT1 — Match output 1 for 32-bit timer 0.
PIO1_7/TXD/ CT32B0_MAT1	D1 <sup>[3]</sup>	D1 <sup>[3]</sup>	no	I/O	I; PU	PIO1_7 — General purpose digital input/output pin.
				O	-	TXD — Transmitter output for UART.
				O	-	CT32B0_MAT1 — Match output 1 for 32-bit timer 0.
				O	-	CT32B0_MAT1 — Match output 1 for 32-bit timer 0.
V <sub>DD</sub>	D2; A1	D2	-	I	-	3.3 V supply voltage to the internal regulator, the external rail, and the ADC. Also used as the ADC reference voltage.
XTALIN	B2 <sup>[5]</sup>	B1 <sup>[5]</sup>	-	I	-	External clock input and input to internal clock generator circuits. Input voltage must not exceed 1.8 V.
V <sub>SS</sub>	D3; B1	D3	-	I	-	Ground.

[1] Pin state at reset for default function: I = Input; PU = internal pull-up enabled (pins pulled up to full V<sub>DD</sub> level (V<sub>DD</sub> = 3.3 V)).

[2] 5 V tolerant pad. See [Figure 22](#) for the reset pad configuration.

[3] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis (see [Figure 21](#)).

[4] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors, configurable hysteresis, and analog input. When configured as a ADC input, digital section of the pad is disabled and the pin is not 5 V tolerant (see [Figure 21](#)).

[5] When the external clock is not used, connect XTALIN as follows: XTALIN can be left floating or can be grounded (grounding is preferred to reduce susceptibility to noise).

## 7. Functional description

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### 7.1 ARM Cortex-M0 processor

The ARM Cortex-M0 is a general purpose, 32-bit microprocessor, which offers high performance and very low power consumption.

### 7.2 On-chip flash program memory

The LPC1102/1104 contain 32 kB of on-chip flash memory.

**Remark:** The LPC1102 supports In-Application Programming (IAP) and In-System Programming (ISP). For ISP, since there is no dedicated ISP entry pin, user code is required to invoke ISP functionality. Unprogrammed parts will automatically boot into ISP mode.

### 7.3 On-chip SRAM

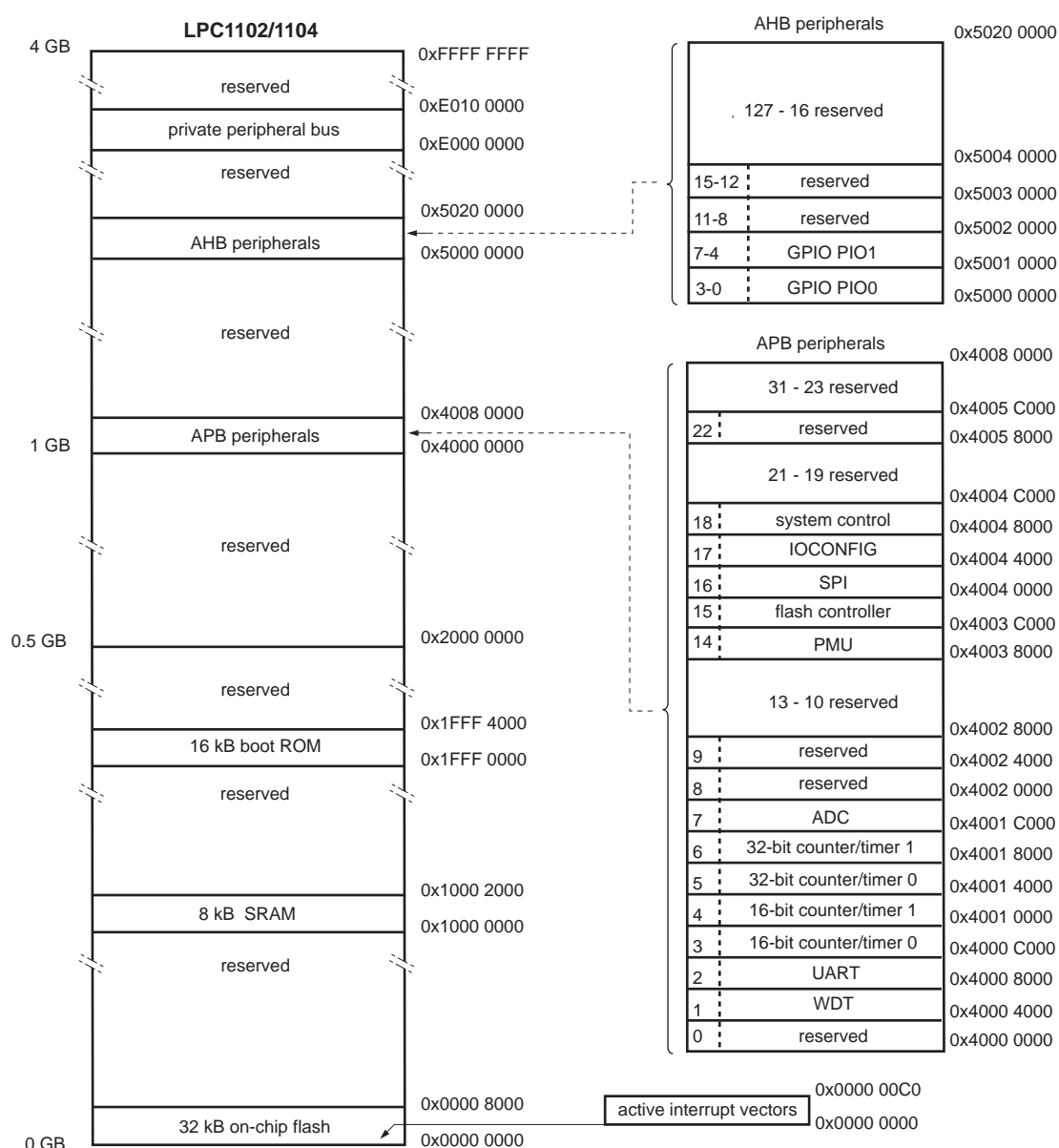
The LPC1102/1104 contain 8 kB on-chip static RAM memory.

### 7.4 Memory map

The LPC1102/1104 incorporate several distinct memory regions, shown in the following figures. [Figure 3](#) shows the overall map of the entire address space from the user program viewpoint following reset. The interrupt vector area supports address remapping.

The AHB peripheral area is 2 MB in size, and is divided to allow for up to 128 peripherals. The APB peripheral area is 512 kB in size and is divided to allow for up to 32 peripherals. Each peripheral of either type is allocated 16 kB of space. This allows simplifying the address decoding for each peripheral.





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Fig 3. LPC1102/1104 memory map

## 7.5 Nested Vectored Interrupt Controller (NVIC)

The Nested Vectored Interrupt Controller (NVIC) is an integral part of the Cortex-M0. The tight coupling to the CPU allows for low interrupt latency and efficient processing of late arriving interrupts.

### 7.5.1 Features

- Controls system exceptions and peripheral interrupts.
- In the LPC1102/1104, the NVIC supports 19 vectored interrupts including up to 6 inputs to the start logic from individual GPIO pins.

- Four programmable interrupt priority levels, with hardware priority level masking.
- Software interrupt generation.

### 7.5.2 Interrupt sources

Each peripheral device has one interrupt line connected to the NVIC but may have several interrupt flags. Individual interrupt flags may also represent more than one interrupt source.

Any GPIO pin (total of up to 11 pins) regardless of the selected function, can be programmed to generate an interrupt on a level, or rising edge or falling edge, or both.

## 7.6 IOCONFIG block

The IOCONFIG block allows selected pins of the microcontroller to have more than one function. Configuration registers control the multiplexers to allow connection between the pin and the on-chip peripherals.

Peripherals should be connected to the appropriate pins prior to being activated and prior to any related interrupt(s) being enabled. Activity of any enabled peripheral function that is not mapped to a related pin should be considered undefined.

## 7.7 Fast general purpose parallel I/O

Device pins that are not connected to a specific peripheral function are controlled by the GPIO registers. Pins may be dynamically configured as inputs or outputs. Multiple outputs can be set or cleared in one write operation.

The LPC1102/1104 use accelerated GPIO functions:

- GPIO registers are a dedicated AHB peripheral so that the fastest possible I/O timing can be achieved.
- Entire port value can be written in one instruction.

Additionally, any GPIO pin (total of 11 pins) providing a digital function can be programmed to generate an interrupt on a level, a rising or falling edge, or both.

### 7.7.1 Features

- Bit level port registers allow a single instruction to set or clear any number of bits in one write operation.
- Direction control of individual bits.
- All I/O default to inputs with pull-ups enabled after reset.
- Pull-up/pull-down resistor configuration can be programmed through the IOCONFIG block for each GPIO pin.
- All GPIO pins are pulled up to 3.3 V ( $V_{DD} = 3.3\text{ V}$ ) if their pull-up resistor is enabled in the IOCONFIG block.
- Programmable open-drain mode.

## 7.8 UART

The LPC1102/1104 contain one UART.

Support for RS-485/9-bit mode allows both software address detection and automatic address detection using 9-bit mode.

The UART includes a fractional baud rate generator. Standard baud rates such as 115200 Bd can be achieved with any crystal frequency above 2 MHz.

### 7.8.1 Features

- Maximum UART data bit rate of 3.125 Mbit/s.
- 16 Byte Receive and Transmit FIFOs.
- Register locations conform to 16C550 industry standard.
- Receiver FIFO trigger points at 1 B, 4 B, 8 B, and 14 B.
- Built-in fractional baud rate generator covering wide range of baud rates without a need for external crystals of particular values.
- FIFO control mechanism that enables software flow control implementation.
- Support for RS-485/9-bit mode.

## 7.9 SPI serial I/O controller

The LPC1102/1104 contain one SPI controller and fully supports SSP features.

The SPI controller is capable of operation on a SSP, 4-wire SSI, or Microwire bus. It can interact with multiple masters and slaves on the bus. Only a single master and a single slave can communicate on the bus during a given data transfer. The SPI supports full duplex transfers, with frames of 4 bits to 16 bits of data flowing from the master to the slave and from the slave to the master. In practice, often only one of these data flows carries meaningful data.

**Remark:** Care must be taken when using the SPI because the SPI clock SCK and the serial wire debug clock SWCLK share the same pin on the WLCSP16 package. Once the SPI is enabled, the serial wire debugger is no longer available (LPC1102 only).

### 7.9.1 Features

- Maximum SPI speed of 25 Mbit/s (master) or 4.17 Mbit/s (slave) (in SSP mode)
- Compatible with Motorola SPI, 4-wire Texas Instruments SSI, and National Semiconductor Microwire buses
- Synchronous serial communication
- Master or slave operation
- 8-frame FIFOs for both transmit and receive
- 4-bit to 16-bit frame

## 7.10 10-bit ADC

The LPC1102/1104 contain one ADC. It is a single 10-bit successive approximation ADC with five channels.

### 7.10.1 Features

- 10-bit successive approximation ADC.

- Input multiplexing among 5 pins.
- Power-down mode.
- Measurement range 0 V to  $V_{DD}$ .
- 10-bit conversion time  $\geq 2.44 \mu\text{s}$  (up to 400 kSamples/s).
- Burst conversion mode for single or multiple inputs.
- Optional conversion on transition of input pin or timer match signal.
- Individual result registers for each ADC channel to reduce interrupt overhead.

## 7.11 General purpose external event counter/timers

The LPC1102/1104 include two 32-bit counter/timers and two 16-bit counter/timers. The counter/timer is designed to count cycles of the system derived clock. It can optionally generate interrupts or perform other actions at specified timer values, based on four match registers. Each counter/timer also includes one capture input to trap the timer value when an input signal transitions, optionally generating an interrupt.

### 7.11.1 Features

- A 32-bit/16-bit timer/counter with a programmable 32-bit/16-bit prescaler.
- Counter or timer operation.
- One capture channel that can take a snapshot of the timer value when an input signal transitions. A capture event may also generate an interrupt.
- Four match registers per timer that allow:
  - Continuous operation with optional interrupt generation on match.
  - Stop timer on match with optional interrupt generation.
  - Reset timer on match with optional interrupt generation.
- Up to four external outputs corresponding to match registers, with the following capabilities:
  - Set LOW on match.
  - Set HIGH on match.
  - Toggle on match.
  - Do nothing on match.

## 7.12 System tick timer

The ARM Cortex-M0 includes a system tick timer (SYSTICK) that is intended to generate a dedicated SYSTICK exception at a fixed time interval (typically 10 ms).

## 7.13 Windowed WatchDog Timer

The purpose of the watchdog is to reset the controller if software fails to periodically service it within a programmable time window.

### 7.13.1 Features

- Internally resets chip if not periodically reloaded during the programmable time-out period.

- Optional windowed operation requires reload to occur between a minimum and maximum time period, both programmable.
- Optional warning interrupt can be generated at a programmable time prior to watchdog time-out.
- Enabled by software but requires a hardware reset or a watchdog reset/interrupt to be disabled.
- Incorrect feed sequence causes reset or interrupt if enabled.
- Flag to indicate watchdog reset.
- Programmable 24-bit timer with internal prescaler.
- Selectable time period from  $(T_{cy(WDCLK)} \times 256 \times 4)$  to  $(T_{cy(WDCLK)} \times 2^{24} \times 4)$  in multiples of  $T_{cy(WDCLK)} \times 4$ .
- The Watchdog Clock (WDCLK) source can be selected from the IRC or the dedicated watchdog oscillator (WDO). This gives a wide range of potential timing choices of watchdog operation under different power conditions.

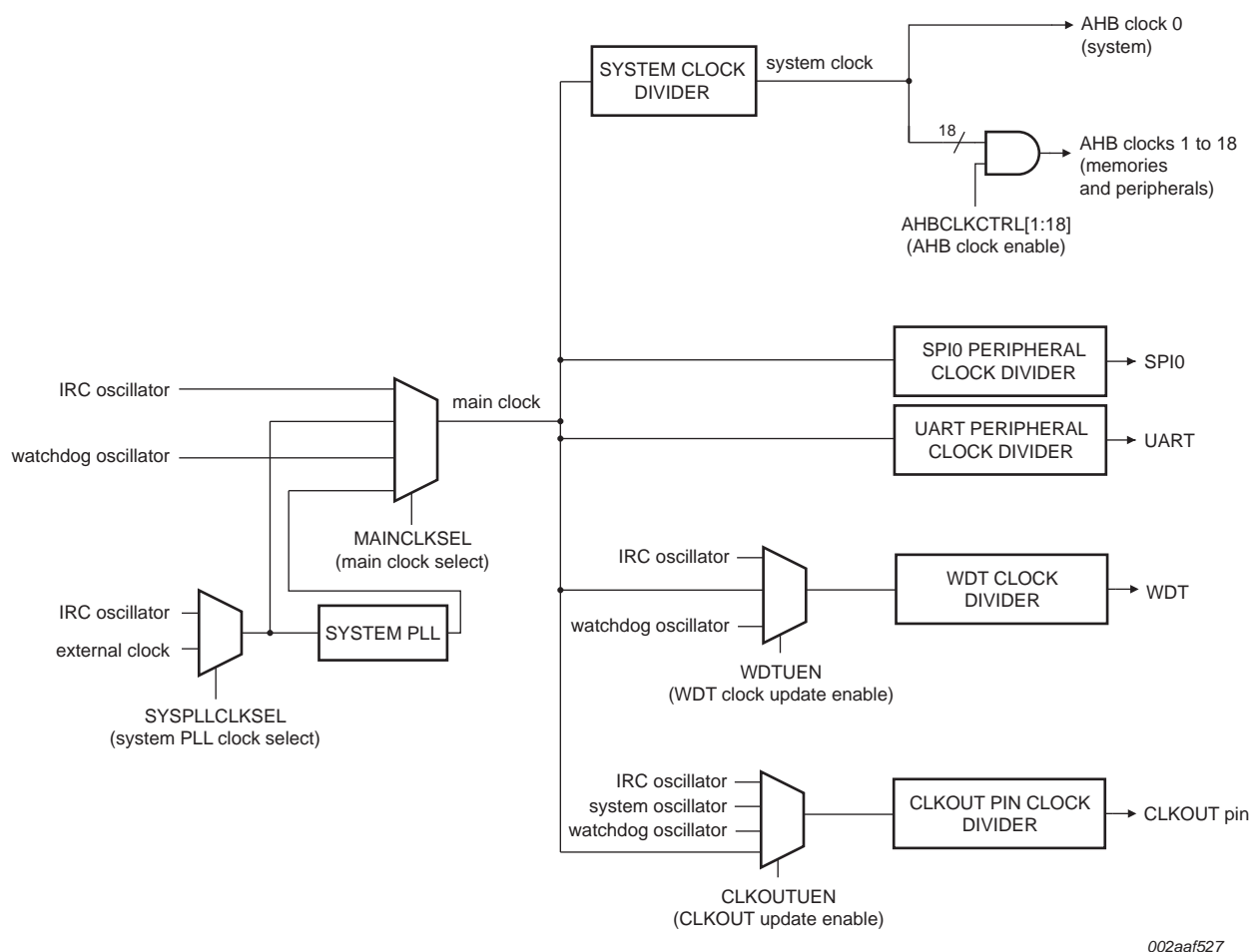
## 7.14 Clocking and power control

### 7.14.1 Crystal oscillators

The LPC1102/1104 include two independent oscillators. These are the Internal RC oscillator (IRC) and the Watchdog oscillator. Each oscillator can be used for more than one purpose as required in a particular application.

Following reset, the LPC1102/1104 operate from the Internal RC oscillator until switched by software. This allows systems to operate without any external crystal and the bootloader code to operate at a known frequency.

See [Figure 4](#) for an overview of the LPC1102/1104 clock generation.



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Fig 4. LPC1102/1104 clock generation block diagram

#### 7.14.1.1 Internal RC oscillator

The IRC may be used as the clock source for the WDT, and/or as the clock that drives the PLL and subsequently the CPU. The nominal IRC frequency is 12 MHz. The IRC is trimmed to 1 % accuracy over the entire voltage and temperature range.

Upon power-up or any chip reset, the LPC1102/1104 use the IRC as the clock source. Software may later switch to one of the other available clock sources.

#### 7.14.1.2 Watchdog oscillator

The watchdog oscillator can be used as a clock source that directly drives the CPU or the watchdog timer. The watchdog oscillator nominal frequency is programmable between 9.4 kHz to 2.3 MHz. The frequency spread over processing and temperature is  $\pm 40$  %.

#### 7.14.2 System PLL

The PLL accepts an input clock frequency in the range of 10 MHz to 25 MHz. The input frequency is multiplied up to a high frequency with a Current Controlled Oscillator (CCO). The multiplier can be an integer value from 1 to 32. The CCO operates in the range of 156 MHz to 320 MHz, so there is an additional divider in the loop to keep the CCO within

its frequency range while the PLL is providing the desired output frequency. The PLL output frequency must be lower than 100 MHz. The output divider may be set to divide by 2, 4, 8, or 16 to produce the output clock. Since the minimum output divider value is 2, it is insured that the PLL output has a 50 % duty cycle. The PLL is turned off and bypassed following a chip reset and may be enabled by software. The program must configure and activate the PLL, wait for the PLL to lock, and then connect to the PLL as a clock source. The PLL settling time is 100  $\mu$ s.

#### 7.14.3 Clock output (LPC1104 only)

The LPC1104 features a clock output function that routes the IRC oscillator, the system oscillator, the watchdog oscillator, or the main clock to an output pin.

#### 7.14.4 Wake-up process

The LPC1102/1104 begin operation at power-up by using the 12 MHz IRC oscillator as the clock source. This allows chip operation to resume quickly. If an external clock or the PLL is needed by the application, software will need to enable these features and wait for them to stabilize before they are used as a clock source.

#### 7.14.5 Power control

The LPC1102/1104 support a variety of power control features. There are two special modes of processor power reduction: Sleep mode and Deep-sleep mode. The CPU clock rate may also be controlled as needed by changing clock sources, reconfiguring PLL values, and/or altering the CPU clock divider value. This allows a trade-off of power versus processing speed based on application requirements. In addition, a register is provided for shutting down the clocks to individual on-chip peripherals, allowing fine tuning of power consumption by eliminating all dynamic power use in any peripherals that are not required for the application. Selected peripherals have their own clock divider which provides even better power control.

##### 7.14.5.1 Power profiles

The power consumption in Active and Sleep modes can be optimized for the application through a simple call to the power profiles. The power configuration routine configures the LPC1102/1104 for one of the following power modes:

- Default mode corresponding to power configuration after reset.
- CPU performance mode corresponding to optimized processing capability.
- Efficiency mode corresponding to optimized balance of current consumption and CPU performance.
- Low-current mode corresponding to lowest power consumption.

In addition, the power profiles includes a routine to select the optimal PLL settings for a given system clock and PLL input clock.

##### 7.14.5.2 Sleep mode

When Sleep mode is entered, the clock to the core is stopped. Resumption from the Sleep mode does not need any special sequence but re-enabling the clock to the ARM core.

In Sleep mode, execution of instructions is suspended until either a reset or interrupt occurs. Peripheral functions continue operation during Sleep mode and may generate interrupts to cause the processor to resume execution. Sleep mode eliminates dynamic power used by the processor itself, memory systems and related controllers, and internal buses.

#### 7.14.5.3 Deep-sleep mode

In Deep-sleep mode, the chip is in Sleep mode, and in addition all analog blocks are shut down except for the watchdog oscillator and the BOD circuit, which can be configured to remain running in Deep-sleep mode to allow a reset initiated by a timer or BOD event. Deep-sleep mode allows for additional power savings.

Six of the GPIO pins (see [Table 3](#)) serve as external wake-up pins to a dedicated start logic to wake up the chip from Deep-sleep mode.

The clock source should be switched to IRC before entering Deep-sleep mode unless the watchdog oscillator remains running in Deep-sleep mode. The IRC can be switched on and off glitch-free and provides a clean clock signal after start-up.

### 7.15 System control

#### 7.15.1 Start logic

The start logic connects external pins to corresponding interrupts in the NVIC. Each pin shown in [Table 3](#) as input to the start logic has an individual interrupt in the NVIC interrupt vector table. The start logic pins can serve as external interrupt pins when the chip is running. In addition, an input signal on the start logic pins can wake up the chip from Deep-sleep mode when all clocks are shut down.

The start logic must be configured in the system configuration block and in the NVIC before being used.

#### 7.15.2 Reset

Reset has four sources on the LPC1102/1104: the  $\overline{\text{RESET}}$  pin, the Watchdog reset, Power-On Reset (POR), and the BrownOut Detection (BOD) circuit. In addition, there is an ARM software reset. The  $\overline{\text{RESET}}$  pin is a Schmitt trigger input pin. Assertion of chip reset by any source, once the operating voltage attains a usable level, starts the IRC and initializes the flash controller.

A LOW-going pulse as short as 50 ns resets the part.

When the internal Reset is removed, the processor begins executing at address 0, which is initially the Reset vector mapped from the boot block. At that point, all of the processor and peripheral registers have been initialized to predetermined values.

#### 7.15.3 Brownout detection

The LPC1102/1104 include up to four levels for monitoring the voltage on the  $V_{DD}$  pin. If this voltage falls below one of the three selected levels, the BOD asserts an interrupt signal to the NVIC. This signal can be enabled for interrupt in the Interrupt Enable Register in the NVIC in order to cause a CPU interrupt; if not, software can monitor the signal by reading a dedicated status register. Four additional threshold levels can be selected to cause a forced reset of the chip.



#### 7.15.4 Code security (Code Read Protection - CRP)

This feature of the LPC1102/1104 allow user to enable different levels of security in the system so that access to the on-chip flash and use of the Serial Wire Debugger (SWD) can be restricted. When needed, CRP is invoked by programming a specific pattern into a dedicated flash location. IAP commands are not affected by the CRP.

There are three levels of Code Read Protection:

1. CRP1 disables access to the chip via the SWD and allows partial flash update (excluding flash sector 0). This mode is useful when CRP is required and flash field updates are needed but all sectors can not be erased.
2. CRP2 disables access to the chip via the SWD and only allows full flash erase and update.
3. Running an application with level CRP3 selected fully disables any access to the chip via the SWD pins.

**Remark:** The LPC1102 does not provide an ISP entry pin to be monitored at reset. For all three CRP levels, the user's application code must provide a flash update mechanism which reinvokes ISP by defining a user-selected PION pin for ISP entry.

#### CAUTION



If Code Read Protection of any level (CRP1, CRP2 or CRP3) is selected, no future factory testing can be performed on the device.

#### 7.15.5 APB interface

The APB peripherals are located on one APB bus.

#### 7.15.6 AHBLite

The AHBLite connects the CPU bus of the ARM Cortex-M0 to the flash memory, the main static RAM, and the Boot ROM.

#### 7.15.7 External interrupt inputs

All GPIO pins can be level or edge sensitive interrupt inputs. In addition, start logic inputs serve as external interrupts (see [Section 7.15.1](#)).

### 7.16 Emulation and debugging

Debug functions are integrated into the ARM Cortex-M0. Serial wire debug with four breakpoints and two watchpoints is supported.

**Remark:** Care must be taken when using the SPI because the SPI clock SCK and the serial wire debug clock SWCLK share the same pin on the WLCSP16 package. Once the SPI is enabled, the serial wire debugger is no longer available (LPC1102 only).

## 8. Limiting values

**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DD</sub>	supply voltage (core and external rail)		<sup>[2]</sup> -0.5	+4.6	V
V <sub>I</sub>	input voltage	5 V tolerant I/O pins; V <sub>DD</sub> ≥ 1.8 V	<sup>[2][3]</sup> -0.5	+5.5	V
		V <sub>DD</sub> = 0 V	-0.5	+3.6	V
V <sub>IA</sub>	analog input voltage	pin configured as analog input	<sup>[2][4]</sup> -0.5	+4.6	V
I <sub>DD</sub>	supply current	per supply pin	<sup>[5]</sup> -	100	mA
I <sub>SS</sub>	ground current	per ground pin	<sup>[5]</sup> -	100	mA
I <sub>latch</sub>	I/O latch-up current	-(0.5V <sub>DD</sub> ) < V <sub>I</sub> < (1.5V <sub>DD</sub> ); T <sub>J</sub> < 125 °C	-	100	mA
T <sub>stg</sub>	storage temperature	non-operating	<sup>[6]</sup> -65	+150	°C
T <sub>j(max)</sub>	maximum junction temperature		-	150	°C
P <sub>tot(pack)</sub>	total power dissipation (per package)	based on package heat transfer, not device power consumption	-	1.5	W
V <sub>ESD</sub>	electrostatic discharge voltage	human body model; all pins	<sup>[7]</sup>	6500	V

[1] The following applies to the limiting values:

- a) This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maximum.
- b) Parameters are valid over operating temperature range unless otherwise specified. All voltages are with respect to V<sub>SS</sub> unless otherwise noted.
- c) The limiting values are stress ratings only. Operating the part at these values is not recommended and proper operation is not guaranteed. The conditions for functional operation are specified in [Table 5](#).

[2] Maximum/minimum voltage above the maximum operating voltage (see [Table 5](#)) and below ground that can be applied for a short time (< 10 ms) to a device without leading to irrecoverable failure. Failure includes the loss of reliability and shorter lifetime of the device.

[3] Including voltage on outputs in 3-state mode.

[4] See [Table 6](#) for maximum operating voltage.

[5] The peak current is limited to 25 times the corresponding maximum current.

[6] The maximum non-operating storage temperature is different than the temperature for required shelf life which should be determined based on required shelf lifetime. Please refer to the JEDEC spec (J-STD-033B.1) for further details.

[7] Human body model: equivalent to discharging a 100 pF capacitor through a 1.5 kΩ series resistor.

## 9. Static characteristics

**Table 5. Static characteristics**

$T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ , unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
V <sub>DD</sub>	supply voltage (core and external rail)		1.8	3.3	3.6	V
I <sub>DD</sub>	supply current	Active mode; code while(1){} executed from flash				
		system clock = 12 MHz V <sub>DD</sub> = 3.3 V	<sup>[2][3][4]</sup> <sup>[5][6]</sup> -	2	-	mA
		system clock = 50 MHz V <sub>DD</sub> = 3.3 V	<sup>[2][3][5]</sup> <sup>[6][7]</sup> -	7	-	mA
		Sleep mode; system clock = 12 MHz V <sub>DD</sub> = 3.3 V	<sup>[2][3][4]</sup> <sup>[5][6]</sup> -	1	-	mA
		Deep-sleep mode; V <sub>DD</sub> = 3.3 V	<sup>[2][3][8]</sup> -	2	-	μA
Standard port pins, RESET						
I <sub>IL</sub>	LOW-level input current	V <sub>I</sub> = 0 V; on-chip pull-up resistor disabled	-	0.5	10	nA
I <sub>IH</sub>	HIGH-level input current	V <sub>I</sub> = V <sub>DD</sub> ; on-chip pull-down resistor disabled	-	0.5	10	nA
I <sub>OZ</sub>	OFF-state output current	V <sub>O</sub> = 0 V; V <sub>O</sub> = V <sub>DD</sub> ; on-chip pull-up/down resistors disabled	-	0.5	10	nA
V <sub>I</sub>	input voltage	pin configured to provide a digital function; V <sub>DD</sub> ≥ 1.8 V; 5 V tolerant pins	<sup>[9]</sup> 0	-	5.0	V
		V <sub>DD</sub> = 0 V	0	-	3.6	V
V <sub>O</sub>	output voltage	output active	0	-	V <sub>DD</sub>	V
V <sub>IH</sub>	HIGH-level input voltage		0.7V <sub>DD</sub>	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.3V <sub>DD</sub>	V
V <sub>hys</sub>	hysteresis voltage		-	0.4	-	V
V <sub>OH</sub>	HIGH-level output voltage	2.5 V ≤ V <sub>DD</sub> ≤ 3.6 V; I <sub>OH</sub> = −4 mA	V <sub>DD</sub> − 0.4	-	-	V
		1.8 V ≤ V <sub>DD</sub> < 2.5 V; I <sub>OH</sub> = −3 mA	V <sub>DD</sub> − 0.4	-	-	V
V <sub>OL</sub>	LOW-level output voltage	2.5 V ≤ V <sub>DD</sub> ≤ 3.6 V; I <sub>OL</sub> = 4 mA	-	-	0.4	V
		1.8 V ≤ V <sub>DD</sub> < 2.5 V; I <sub>OL</sub> = 3 mA	-	-	0.4	V

**Table 5. Static characteristics ...continued** $T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ , unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
$I_{OH}$	HIGH-level output current	$V_{OH} = V_{DD} - 0.4\text{ V}$ ; $2.5\text{ V} \leq V_{DD} \leq 3.6\text{ V}$	-4	-	-	mA
		$1.8\text{ V} \leq V_{DD} < 2.5\text{ V}$	-3	-	-	mA
$I_{OL}$	LOW-level output current	$V_{OL} = 0.4\text{ V}$ $2.5\text{ V} \leq V_{DD} \leq 3.6\text{ V}$	4	-	-	mA
		$1.8\text{ V} \leq V_{DD} < 2.5\text{ V}$	3	-	-	mA
$I_{OHS}$	HIGH-level short-circuit output current	$V_{OH} = 0\text{ V}$	<sup>[11]</sup> -	-	-45	mA
$I_{OLS}$	LOW-level short-circuit output current	$V_{OL} = V_{DD}$	<sup>[11]</sup> -	-	50	mA
$I_{pd}$	pull-down current	$V_I = 5\text{ V}$	10	50	150	$\mu\text{A}$
$I_{pu}$	pull-up current	$V_I = 0\text{ V}$ ; $2.0\text{ V} \leq V_{DD} \leq 3.6\text{ V}$	-15	-50	-85	$\mu\text{A}$
		$1.8\text{ V} \leq V_{DD} < 2.0\text{ V}$	-10	-50	-85	$\mu\text{A}$
		$V_{DD} < V_I < 5\text{ V}$	0	0	0	$\mu\text{A}$
<b>External clock input</b>						
$V_{i(xtal)}$	crystal input voltage		-0.5	1.8	1.95	V

[1] Typical ratings are not guaranteed. The values listed are at room temperature ( $25\text{ }^{\circ}\text{C}$ ), nominal supply voltages.

[2]  $T_{amb} = 25\text{ }^{\circ}\text{C}$ .

[3]  $I_{DD}$  measurements were performed with all pins configured as GPIO outputs driven LOW and pull-up resistors disabled.

[4] IRC enabled; external clock disabled; system PLL disabled.

[5] BOD disabled.

[6] All peripherals disabled in the SYSAHBCLKCTRL register. Peripheral clocks to UART and SPI0/1 disabled in system configuration block. Low-current mode PWR\_LOW\_CURRENT selected when running the set\_power routine in the power profiles.

[7] IRC disabled; system oscillator enabled; system PLL enabled.

[8] All oscillators and analog blocks turned off in the PDSLEEPCFG register; PDSLEEPCFG = 0x0000 18FF. Before entering deep-sleep mode, you must write a 0 to bit 4 and bit 5 of the GPIO0DATA register at location 0x5000 3FFC and a 1 to bit 4 and bit 5 of the GPIO0DIR register at location 0x5000 8000.

[9] Including voltage on outputs in 3-state mode.

[10]  $V_{DD}$  supply voltage must be present.

[11] Allowed as long as the current limit does not exceed the maximum current allowed by the device.

**Table 6. ADC static characteristics**

$T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$  unless otherwise specified; ADC frequency 4.5 MHz,  $V_{DD} = 2.5\text{ V}$  to  $3.6\text{ V}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IA}$	analog input voltage		0	-	$V_{DD}$	V
$C_{ia}$	analog input capacitance		-	-	1	pF
$E_D$	differential linearity error	[1][2]	-	-	$\pm 1$	LSB
$E_{L(adj)}$	integral non-linearity	[3]	-	-	$\pm 1.5$	LSB
$E_O$	offset error	[4]	-	-	$\pm 3.5$	LSB
$E_G$	gain error	[5]	-	-	0.6	%
$E_T$	absolute error	[6]	-	-	$\pm 4$	LSB
$R_{vsi}$	voltage source interface resistance		-	-	40	k $\Omega$
$R_i$	input resistance	[7][8]	-	-	2.5	M $\Omega$

[1] The ADC is monotonic, there are no missing codes.

[2] The differential linearity error ( $E_D$ ) is the difference between the actual step width and the ideal step width. See [Figure 5](#).

[3] The integral non-linearity ( $E_{L(adj)}$ ) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See [Figure 5](#).

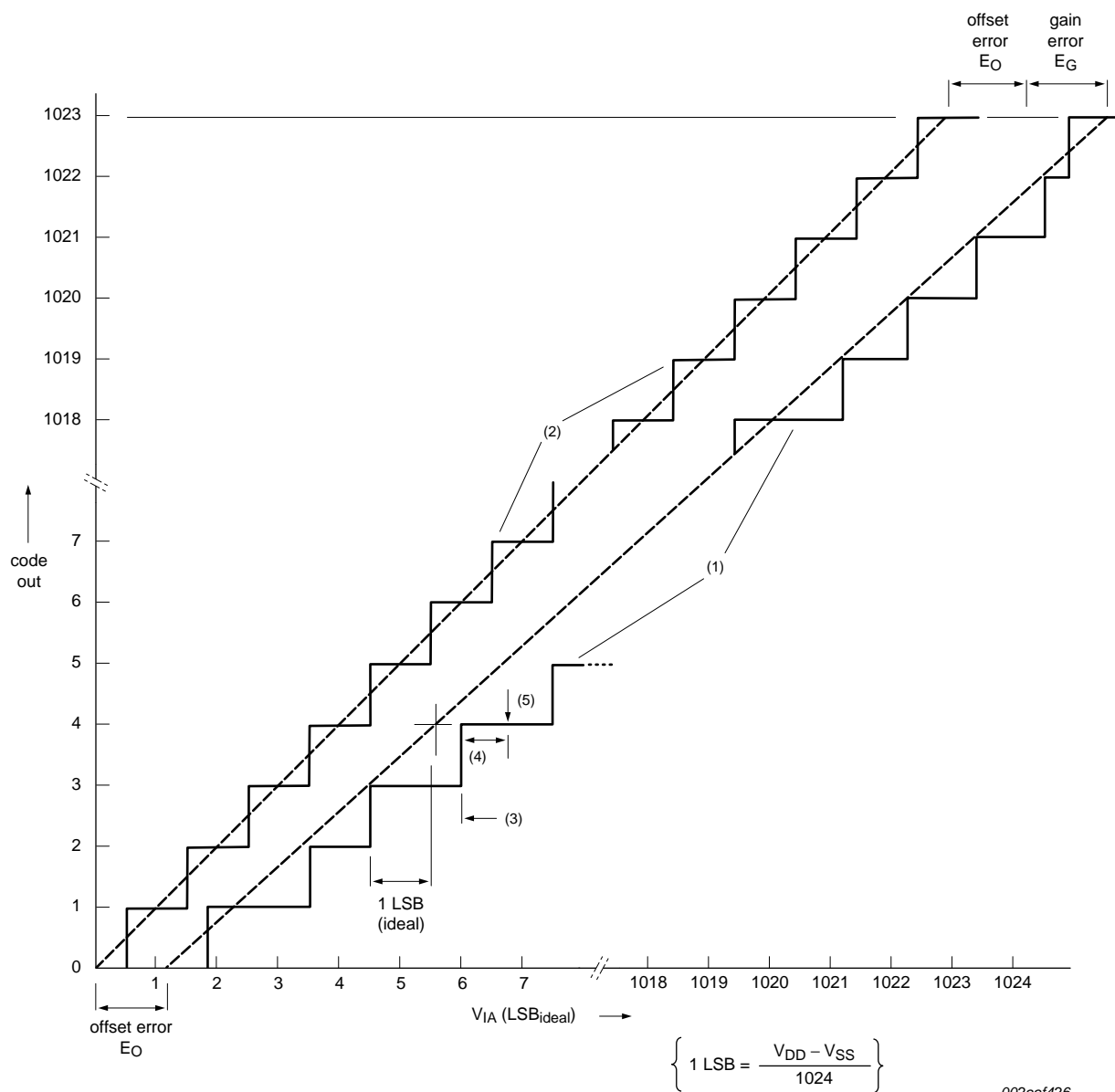
[4] The offset error ( $E_O$ ) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See [Figure 5](#).

[5] The gain error ( $E_G$ ) is the relative difference in percent between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See [Figure 5](#).

[6] The absolute error ( $E_T$ ) is the maximum difference between the center of the steps of the actual transfer curve of the non-calibrated ADC and the ideal transfer curve. See [Figure 5](#).

[7]  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ; maximum sampling frequency  $f_s = 400\text{ kSamples/s}$  and analog input capacitance  $C_{ia} = 1\text{ pF}$ .

[8] Input resistance  $R_i$  depends on the sampling frequency  $f_s$ :  $R_i = 1 / (f_s \times C_{ia})$ .



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- (1) Example of an actual transfer curve.
- (2) The ideal transfer curve.
- (3) Differential linearity error ( $E_D$ ).
- (4) Integral non-linearity ( $E_{L(\text{adj})}$ ).
- (5) Center of a step of the actual transfer curve.

**Fig 5. ADC characteristics**

## 9.1 BOD static characteristics

**Table 7. BOD static characteristics<sup>[1]</sup>**

$T_{amb} = 25\text{ }^{\circ}\text{C}$ .

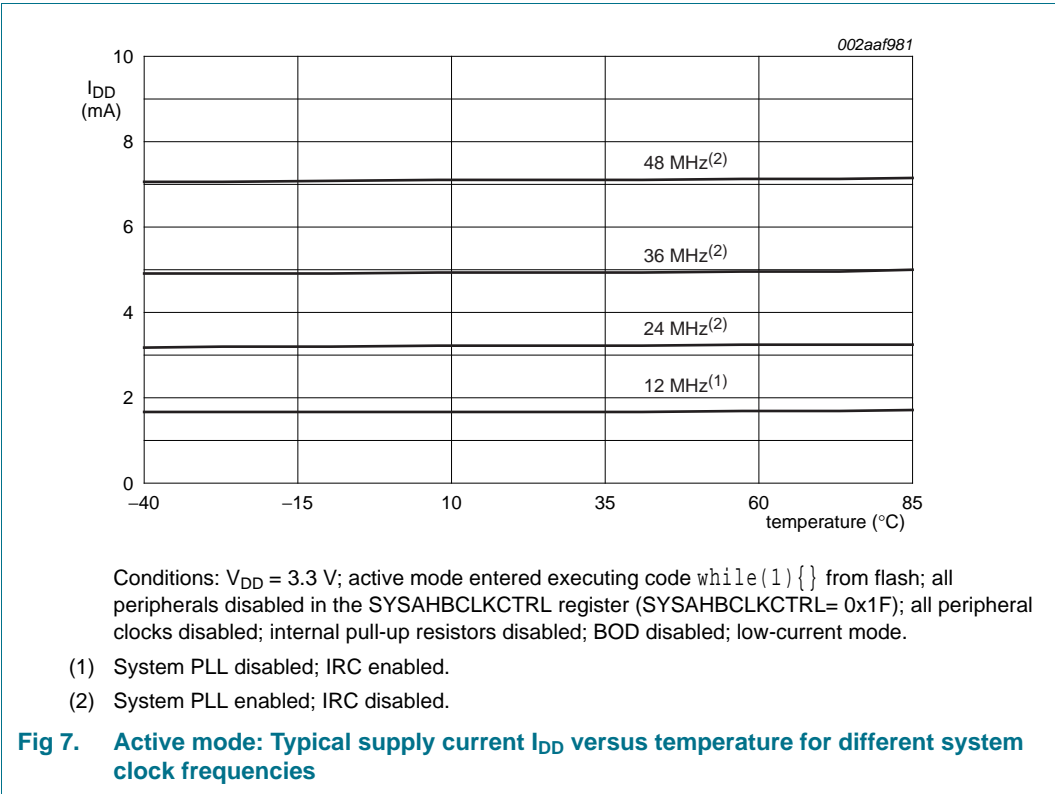
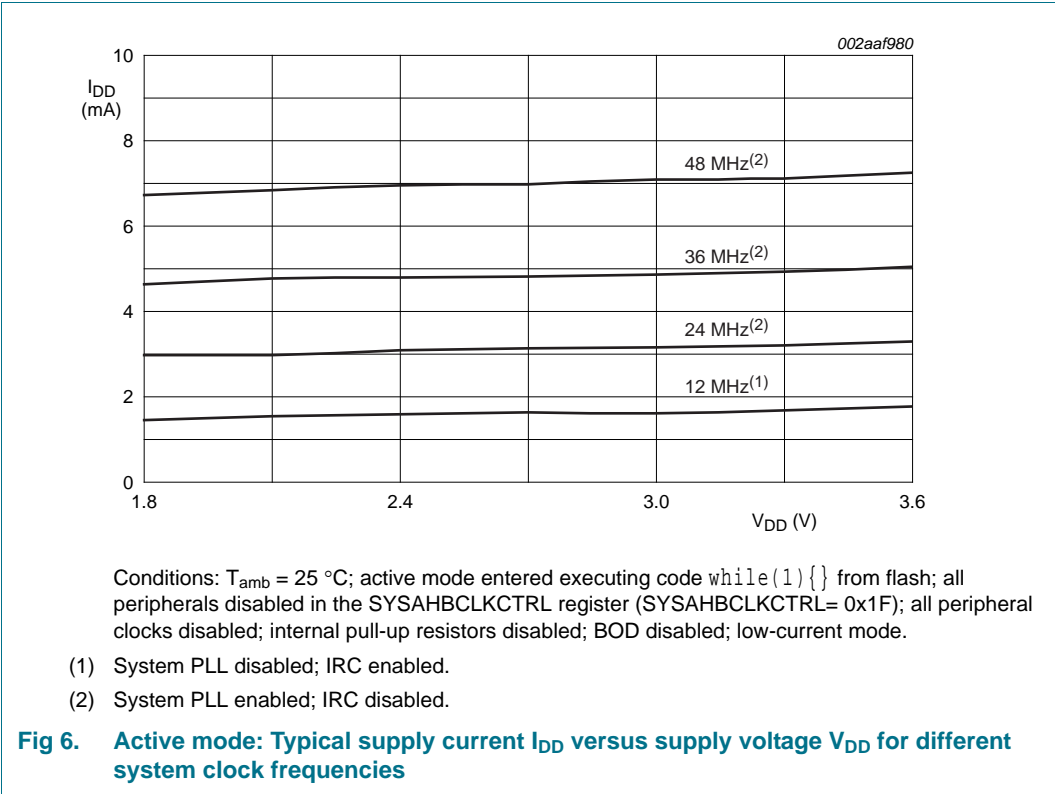
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{th}$	threshold voltage	interrupt level 1				
		assertion	-	2.22	-	V
		de-assertion	-	2.35	-	V
		interrupt level 2				
		assertion	-	2.52	-	V
		de-assertion	-	2.66	-	V
		interrupt level 3				
		assertion	-	2.80	-	V
		de-assertion	-	2.90	-	V
		reset level 0				
		assertion	-	1.46	-	V
		de-assertion	-	1.63	-	V
		reset level 1				
		assertion	-	2.06	-	V
		de-assertion	-	2.15	-	V
		reset level 2				
		assertion	-	2.35	-	V
		de-assertion	-	2.43	-	V
		reset level 3				
		assertion	-	2.63	-	V
		de-assertion	-	2.71	-	V

[1] Interrupt levels are selected by writing the level value to the BOD control register BODCTRL, see *User manual UM10429*.

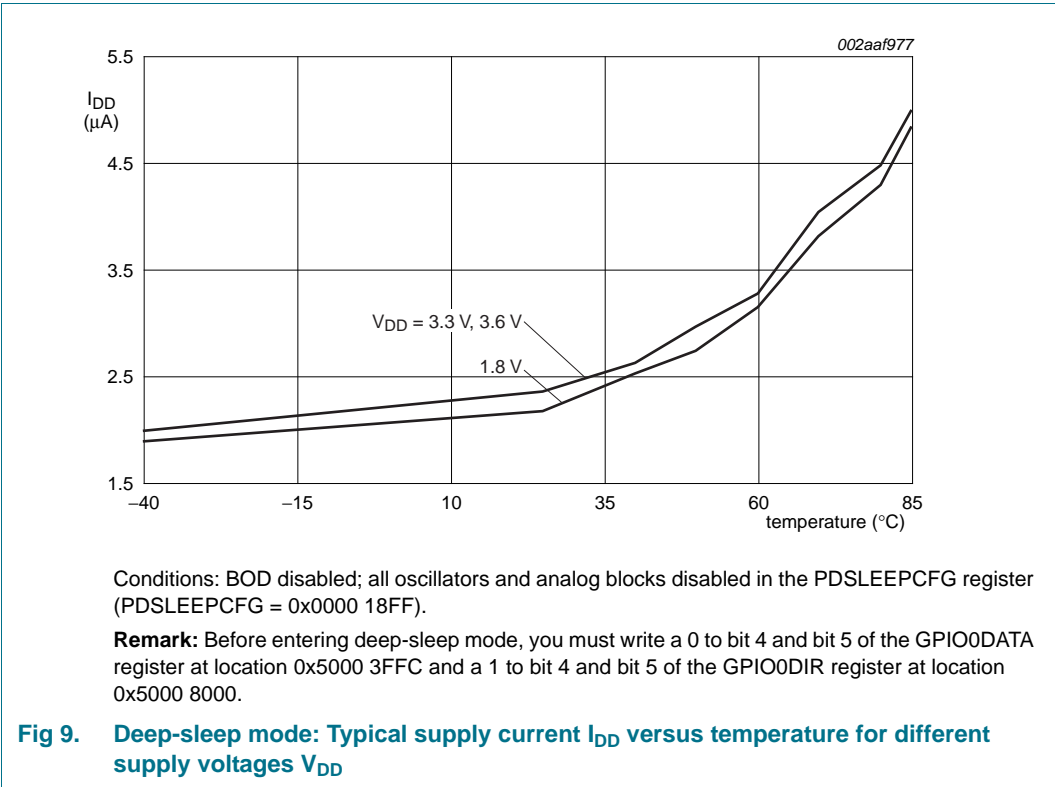
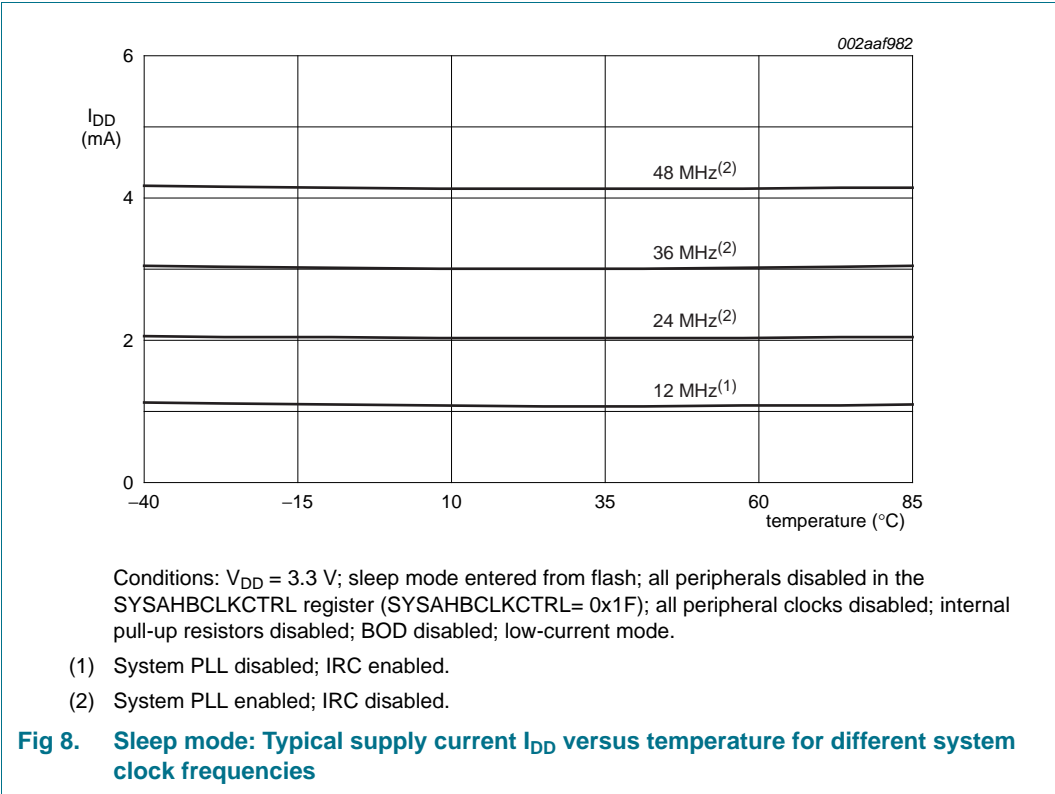
## 9.2 Power consumption

Power measurements in Active, Sleep, and Deep-sleep modes were performed under the following conditions (see *user manual UM10429*):

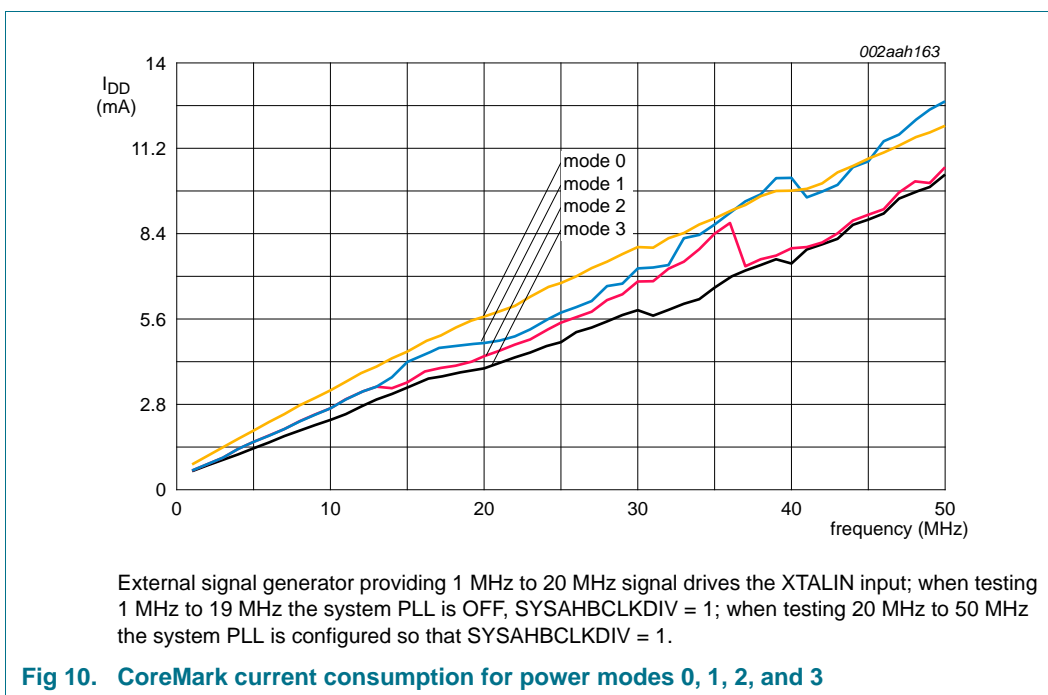
- All digital pins configured as GPIO with pull-up resistor disabled in the IOCONFIG block.
- GPIO pins configured as outputs using the GPIODIR registers.
- Write 0 to all GPIODATA registers to drive the outputs LOW.
- Write a 1 to bit 4 and bit 5 of the GPIO0DIR register at location 0x5000 8000 and a 0 to bit 4 and bit 5 of the GPIO0DATA register at location 0x5000 3FFC. This ensures that not-bonded out pins are in a well-defined state.



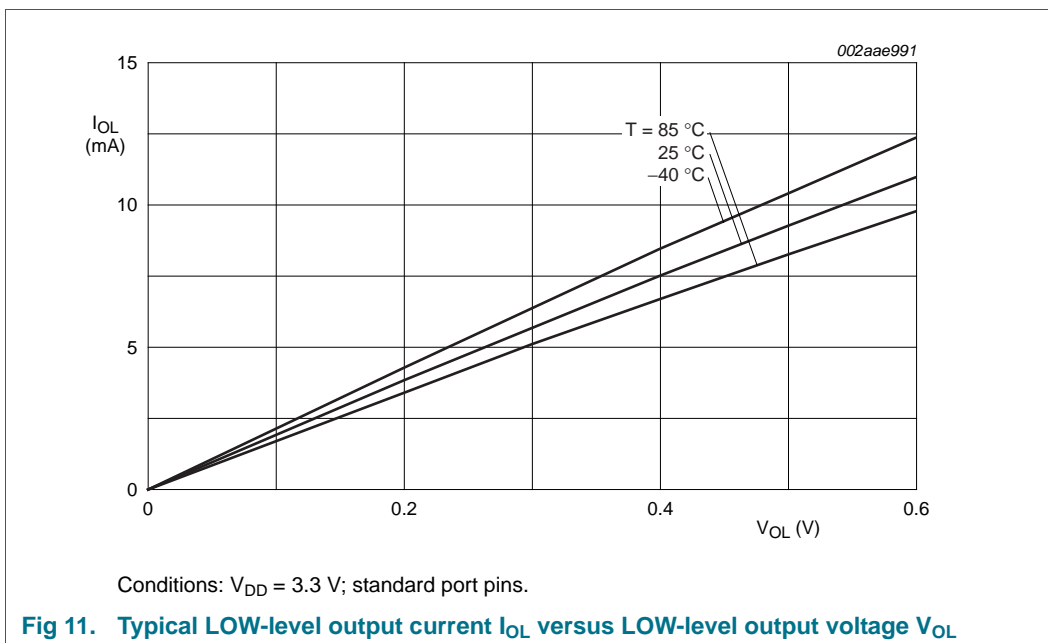


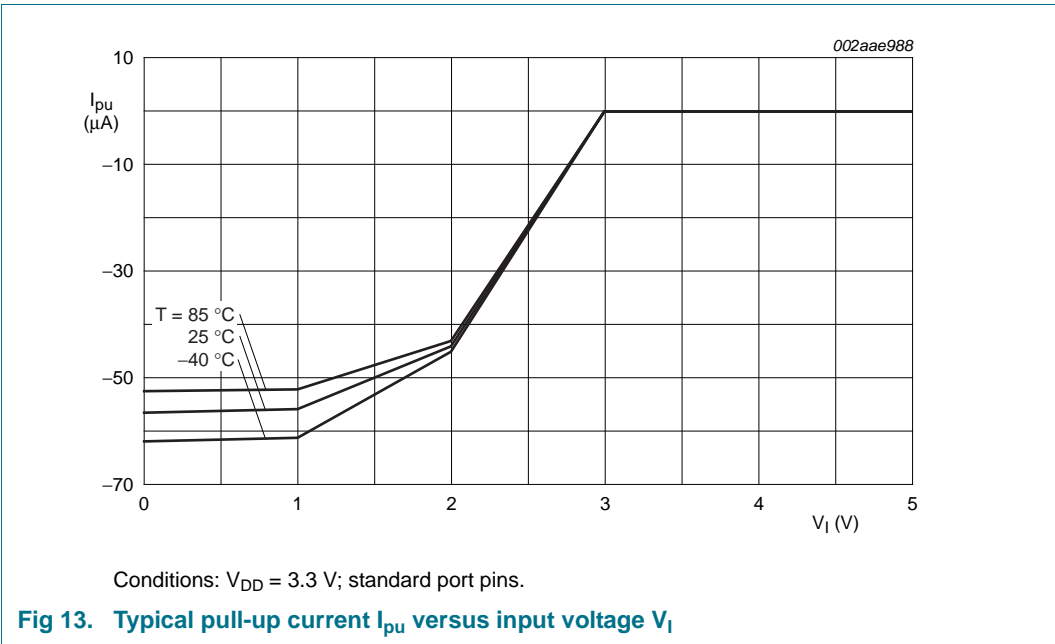
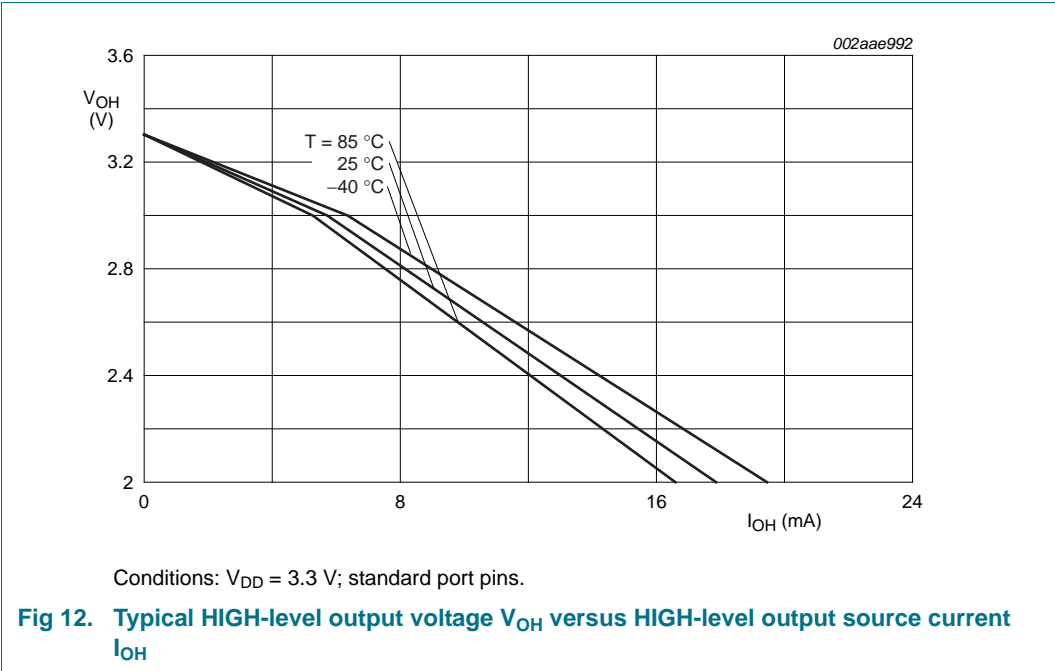


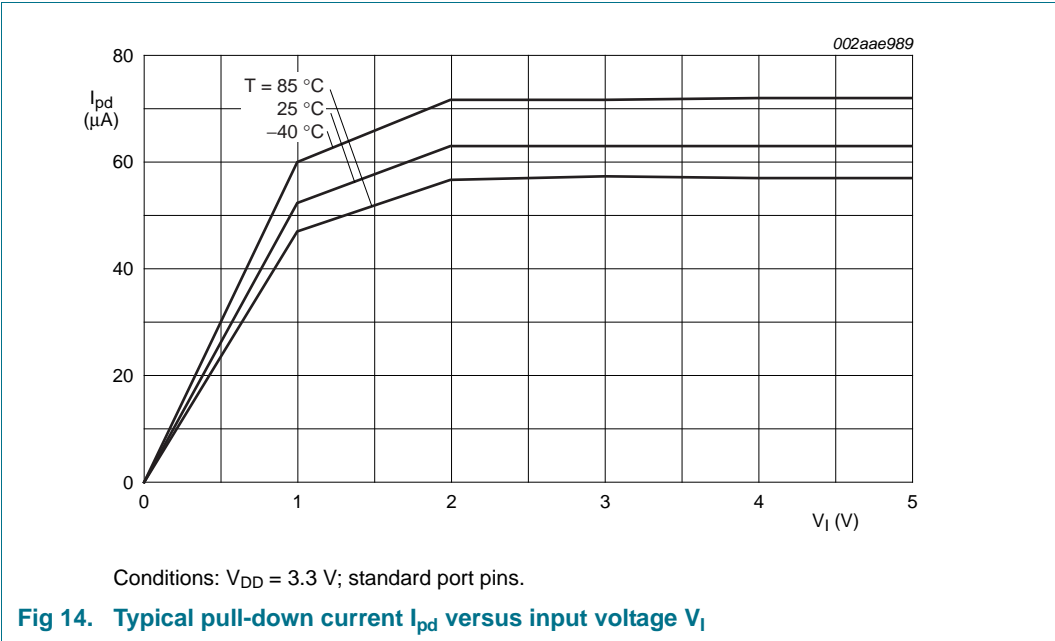
### 9.3 CoreMark data



### 9.4 Electrical pin characteristics







## 10. Dynamic characteristics

### 10.1 Power-up ramp conditions

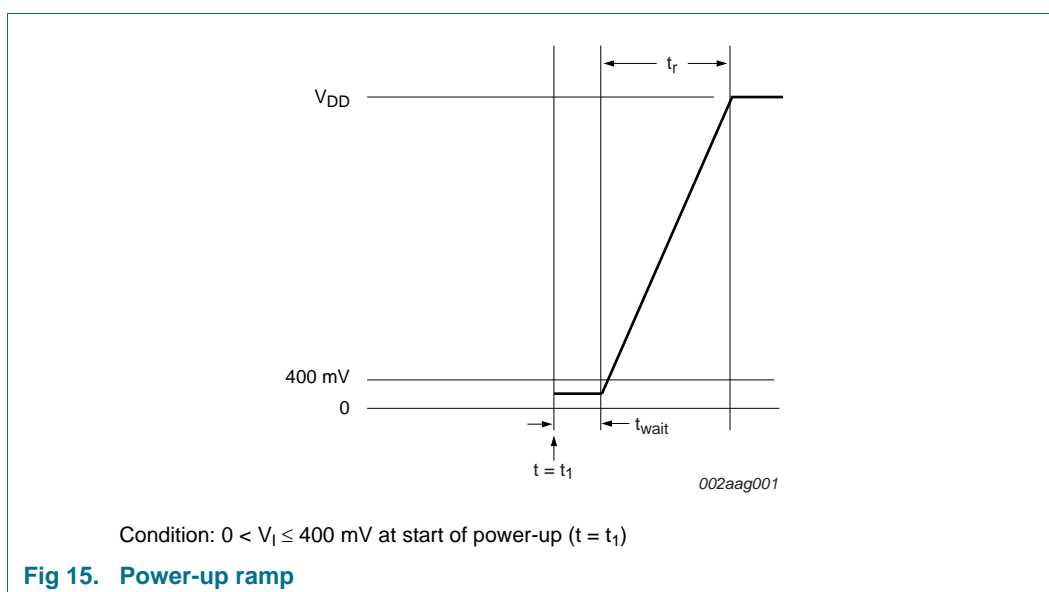
**Table 8. Power-up characteristics**

$T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_r$	rise time	at $t = t_1$ : $0 < V_I \leq 400\text{ mV}$	[1] 0	-	500	ms
$t_{wait}$	wait time		[1][2] 12	-	-	$\mu\text{s}$
$V_I$	input voltage	at $t = t_1$ on pin $V_{DD}$	0	-	400	mV

[1] See [Figure 15](#).

[2] The wait time specifies the time the power supply must be at levels below 400 mV before ramping up.



**Fig 15. Power-up ramp**

### 10.2 Flash memory

**Table 9. Flash characteristics**

$T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ , unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$N_{endu}$	endurance		[1] 10000	100 000	-	cycles
$t_{ret}$	retention time	powered	10	-	-	years
		unpowered	20	-	-	years
$t_{er}$	erase time	sector or multiple consecutive sectors	95	100	105	ms
$t_{prog}$	programming time		[2] 0.95	1	1.05	ms

[1] Number of program/erase cycles.

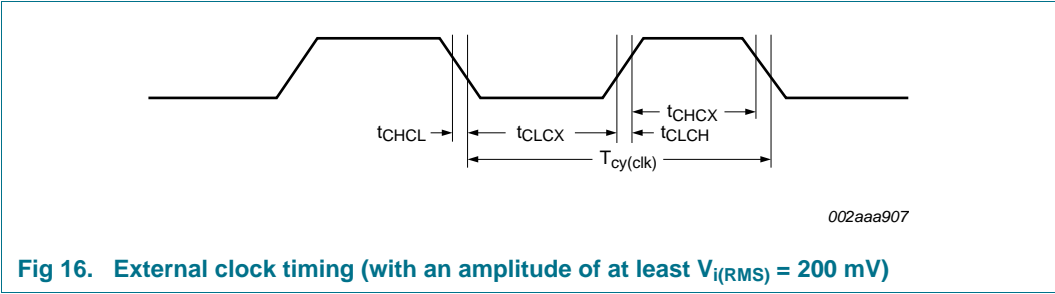
[2] Programming times are given for writing 256 bytes from RAM to the flash. Data must be written to the flash in blocks of 256 bytes.

10.3 External clock

Table 10. Dynamic characteristic: external clock  
 $T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ ;  $V_{DD}$  over specified ranges.<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Typ <sup>[2]</sup>	Max	Unit
$f_{osc}$	oscillator frequency		1	-	25	MHz
$T_{cy(clk)}$	clock cycle time		40	-	1000	ns
$t_{CHCX}$	clock HIGH time		$T_{cy(clk)} \times 0.4$	-	-	ns
$t_{CLCX}$	clock LOW time		$T_{cy(clk)} \times 0.4$	-	-	ns
$t_{CLCH}$	clock rise time		-	-	5	ns
$t_{CHCL}$	clock fall time		-	-	5	ns

- [1] Parameters are valid over operating temperature range unless otherwise specified.
- [2] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.



## 10.4 Internal oscillators

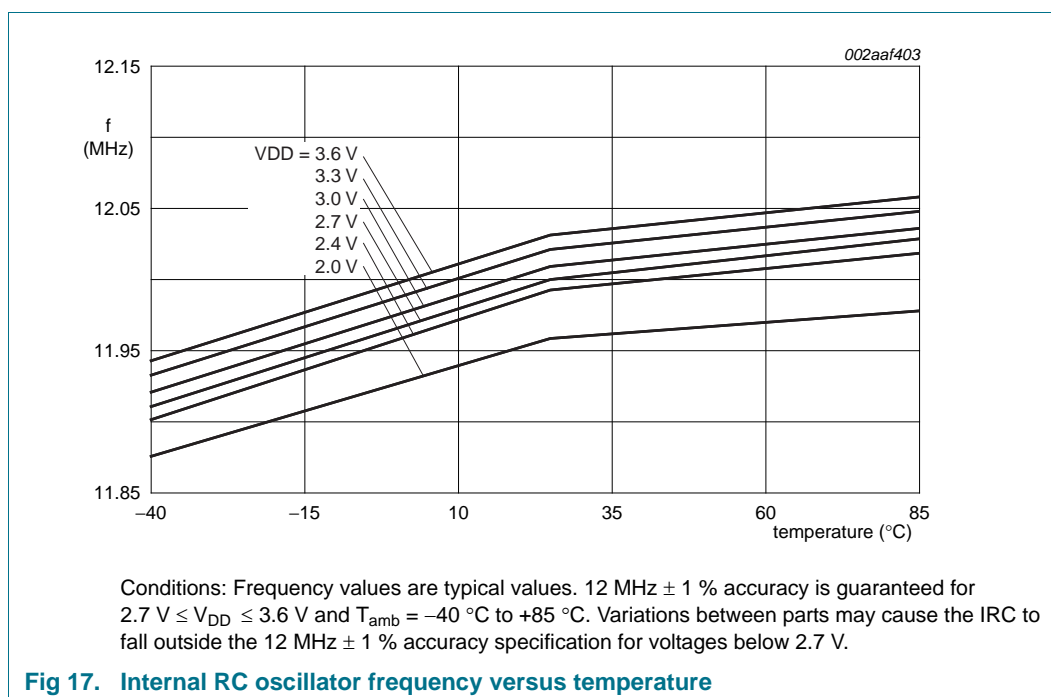
**Table 11. Dynamic characteristic: internal oscillators**

$T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ ;  $2.7\text{ V} \leq V_{DD} \leq 3.6\text{ V}$ .<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Typ <sup>[2]</sup>	Max	Unit
$f_{osc(RC)}$	internal RC oscillator frequency	-	11.88	12	12.12	MHz

[1] Parameters are valid over operating temperature range unless otherwise specified.

[2] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.



**Fig 17. Internal RC oscillator frequency versus temperature**

**Table 12. Dynamic characteristics: Watchdog oscillator**

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
$f_{osc(int)}$	internal oscillator frequency	DIVSEL = 0x1F, FREQSEL = 0x1 in the WDTOSCCTRL register;	<sup>[2][3]</sup> -	9.4	-	kHz
		DIVSEL = 0x00, FREQSEL = 0xF in the WDTOSCCTRL register	<sup>[2][3]</sup> -	2300	-	kHz

[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

[2] The typical frequency spread over processing and temperature ( $T_{amb} = -40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$ ) is  $\pm 40\%$ .

[3] See *user manual UM10429*.

## 10.5 I/O pins

**Table 13. Dynamic characteristic: I/O pins<sup>[1]</sup>**

$T_{amb} = -40\text{ }^{\circ}\text{C to }+85\text{ }^{\circ}\text{C}; 3.0\text{ V} \leq V_{DD} \leq 3.6\text{ V}.$

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_r$	rise time	pin configured as output	3.0	-	5.0	ns
$t_f$	fall time	pin configured as output	2.5	-	5.0	ns

[1] Applies to standard port pins and RESET pin.

## 10.6 SPI interfaces

**Table 14. Dynamic characteristics of SPI pins in SPI mode**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>SPI master (in SPI mode)</b>						
$T_{cy(clk)}$	clock cycle time	when only receiving <sup>[1]</sup>	50	-	-	ns
		when only transmitting <sup>[1]</sup>	40			ns
$t_{DS}$	data set-up time	in SPI mode <sup>[2]</sup>	15	-	-	ns
		$2.4\text{ V} \leq V_{DD} \leq 3.6\text{ V}$				
		$2.0\text{ V} \leq V_{DD} < 2.4\text{ V}$ <sup>[2]</sup>	20			ns
		$1.8\text{ V} \leq V_{DD} < 2.0\text{ V}$ <sup>[2]</sup>	24	-	-	ns
$t_{DH}$	data hold time	in SPI mode <sup>[2]</sup>	0	-	-	ns
$t_{v(Q)}$	data output valid time	in SPI mode <sup>[2]</sup>	-	-	10	ns
$t_{h(Q)}$	data output hold time	in SPI mode <sup>[2]</sup>	0	-	-	ns
<b>SPI slave (in SPI mode)</b>						
$T_{cy(PCLK)}$	PCLK cycle time		20	-	-	ns
$t_{DS}$	data set-up time	in SPI mode <sup>[3][4]</sup>	0	-	-	ns
$t_{DH}$	data hold time	in SPI mode <sup>[3][4]</sup>	$3 \times T_{cy(PCLK)} + 4$	-	-	ns
$t_{v(Q)}$	data output valid time	in SPI mode <sup>[3][4]</sup>	-	-	$3 \times T_{cy(PCLK)} + 11$	ns
$t_{h(Q)}$	data output hold time	in SPI mode <sup>[3][4]</sup>	-	-	$2 \times T_{cy(PCLK)} + 5$	ns

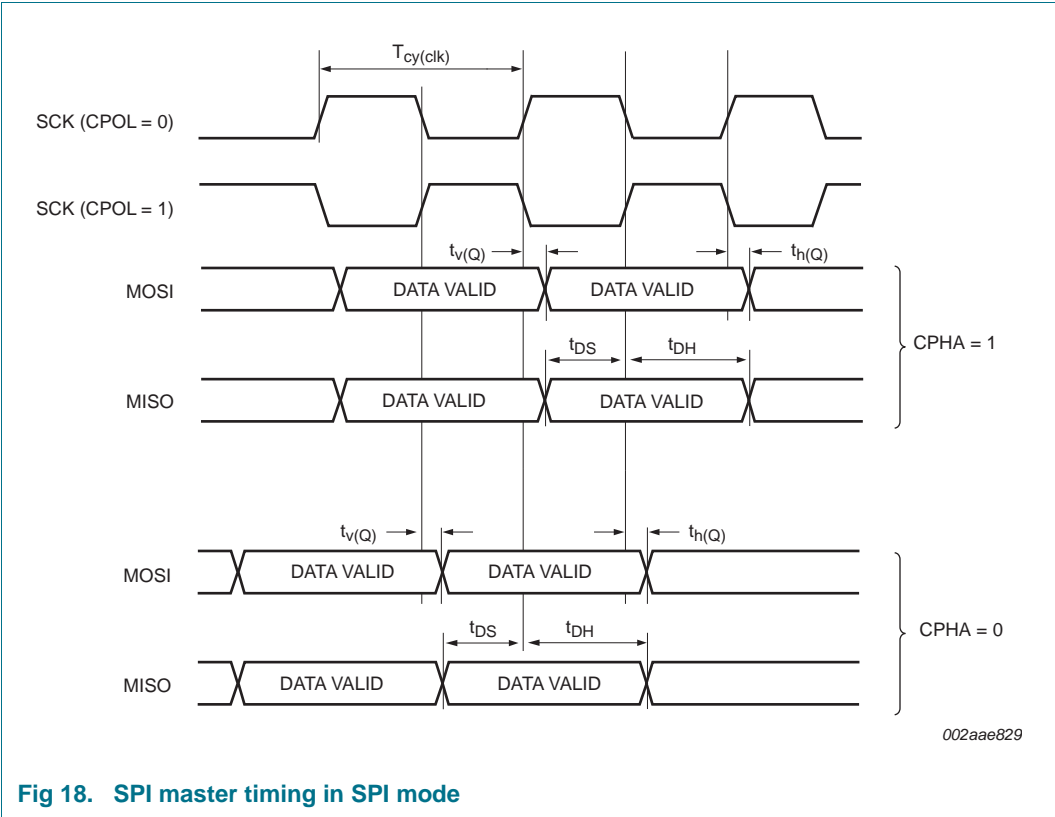
[1]  $T_{cy(clk)} = (SSPCLKDIV \times (1 + SCR) \times CPDVSRR) / f_{main}$ . The clock cycle time derived from the SPI bit rate  $T_{cy(clk)}$  is a function of the main clock frequency  $f_{main}$ , the SPI peripheral clock divider (SSPCLKDIV), the SPI SCR parameter (specified in the SSP0CR0 register), and the SPI CPDVSRR parameter (specified in the SPI clock prescale register).

[2]  $T_{amb} = -40\text{ }^{\circ}\text{C to }85\text{ }^{\circ}\text{C}.$

[3]  $T_{cy(clk)} = 12 \times T_{cy(PCLK)}.$

[4]  $T_{amb} = 25\text{ }^{\circ}\text{C};$  for normal voltage supply range:  $V_{DD} = 3.3\text{ V}.$





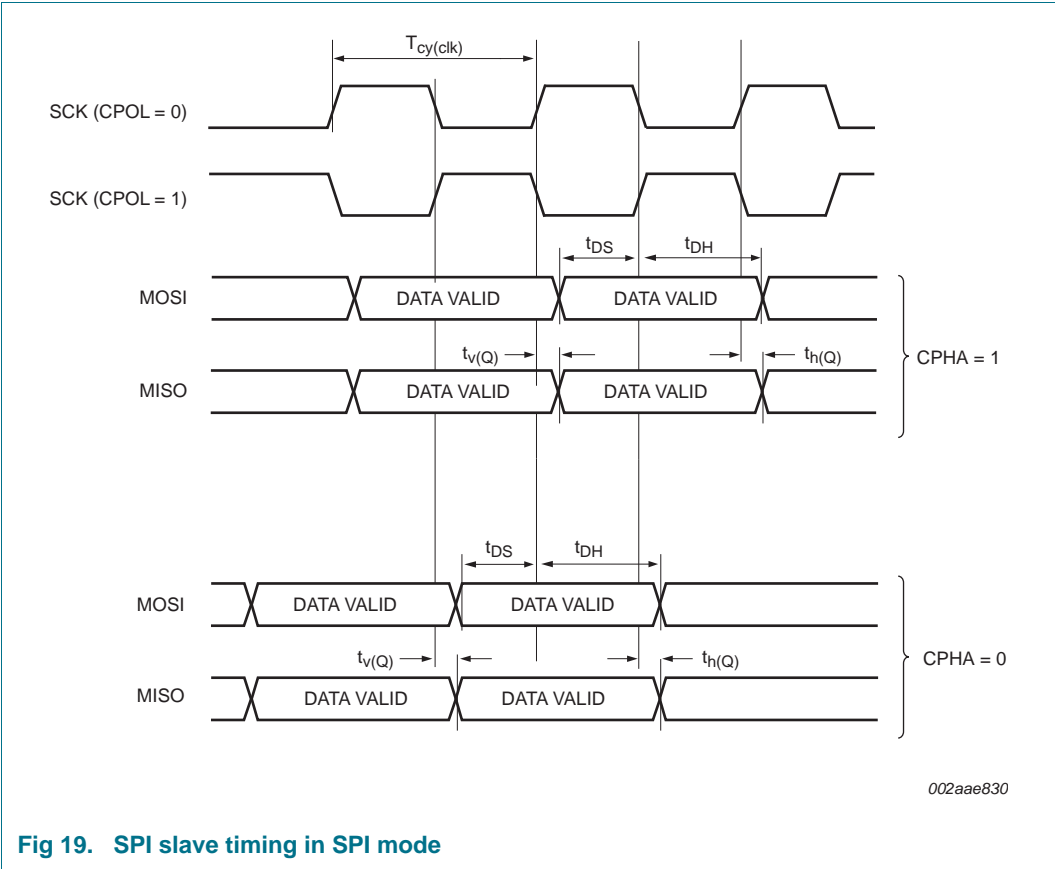


Fig 19. SPI slave timing in SPI mode

## 11. Application information

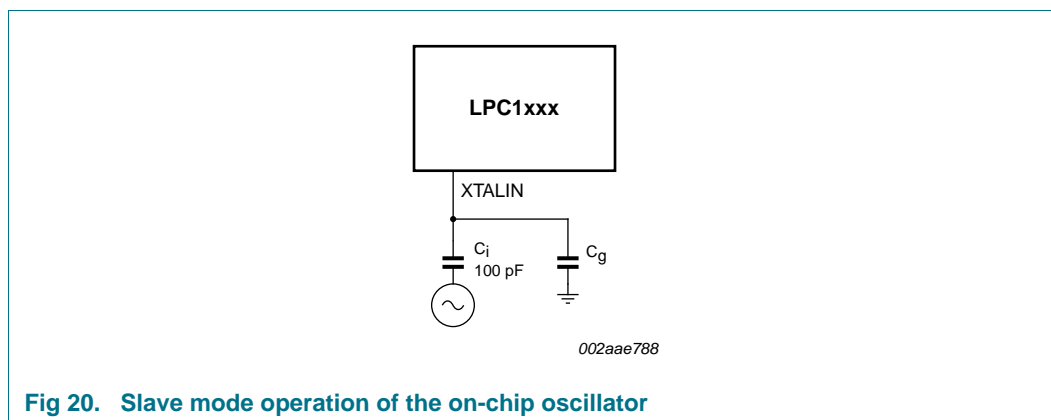
### 11.1 ADC usage notes

The following guidelines show how to increase the performance of the ADC in a noisy environment beyond the ADC specifications listed in [Table 6](#):

- The ADC input trace must be short and as close as possible to the LPC1102/1104 chip.
- The ADC input traces must be shielded from fast switching digital signals and noisy power supply lines.
- Because the ADC and the digital core share the same power supply, the power supply line must be adequately filtered.
- To improve the ADC performance in a very noisy environment, put the device in Sleep mode during the ADC conversion.

### 11.2 XTAL input

The input voltage to the on-chip oscillators is limited to 1.8 V. If the oscillator is driven by a clock in slave mode, it is recommended that the input be coupled through a capacitor with  $C_i = 100$  pF. To limit the input voltage to the specified range, choose an additional capacitor to ground  $C_g$  which attenuates the input voltage by a factor  $C_i/(C_i + C_g)$ . In slave mode, a minimum of 200 mV (RMS) is needed.



In slave mode the input clock signal should be coupled by means of a capacitor of 100 pF ([Figure 20](#)), with an amplitude between 200 mV (RMS) and 1000 mV (RMS). This corresponds to a square wave signal with a signal swing of between 280 mV and 1.4 V.

### 11.3 Standard I/O pad configuration

[Figure 21](#) shows the possible pin modes for standard I/O pins with analog input function:

- Digital output driver
- Digital input: Pull-up enabled/disabled
- Digital input: Pull-down enabled/disabled
- Digital input: Repeater mode enabled/disabled
- Analog input

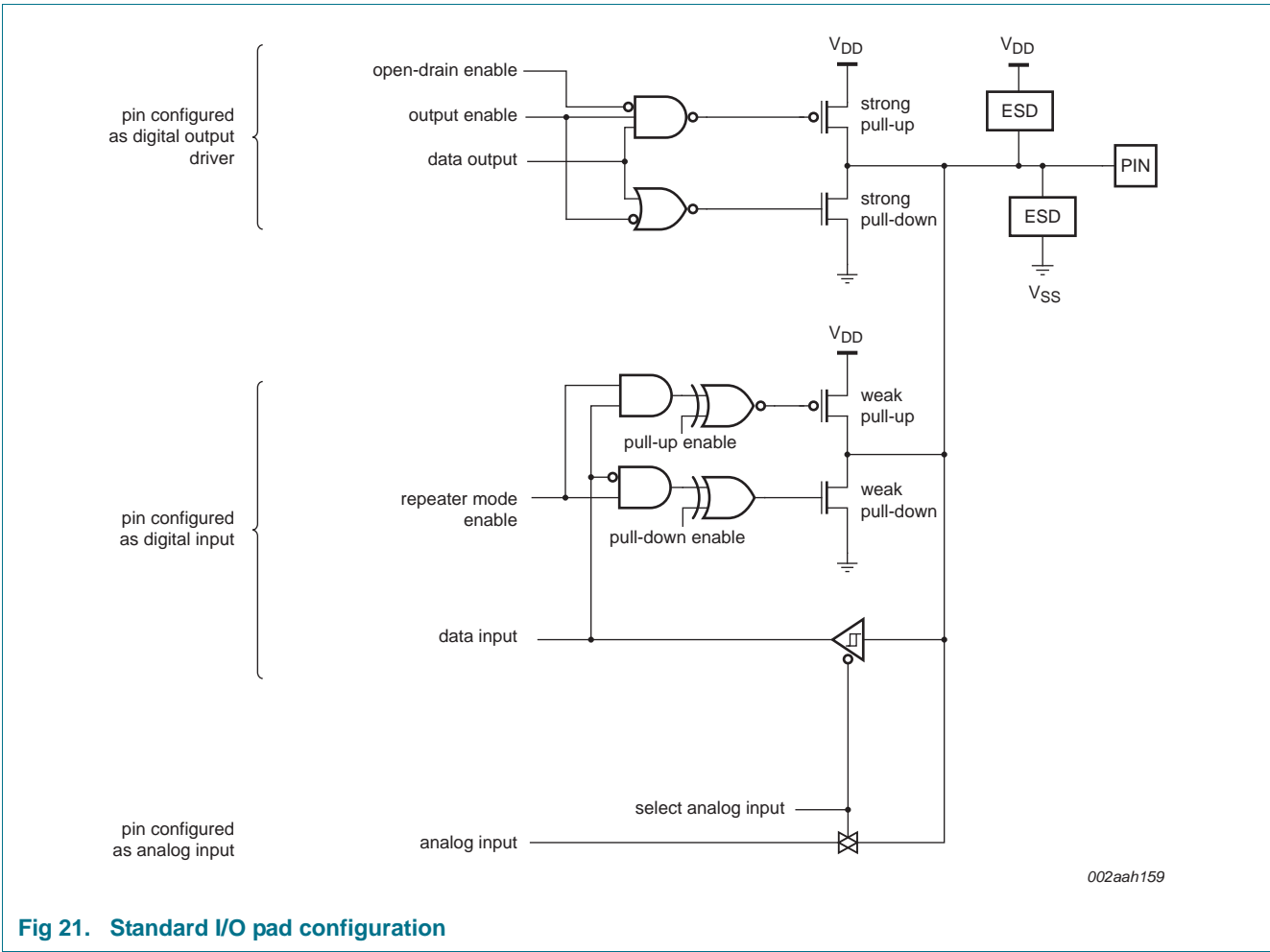


Fig 21. Standard I/O pad configuration

11.4 Reset pad configuration

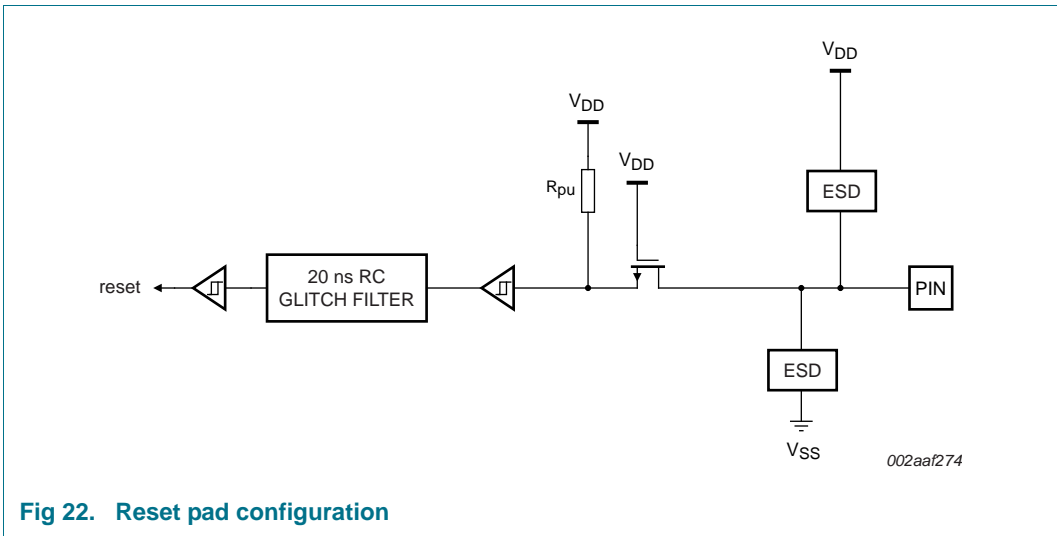
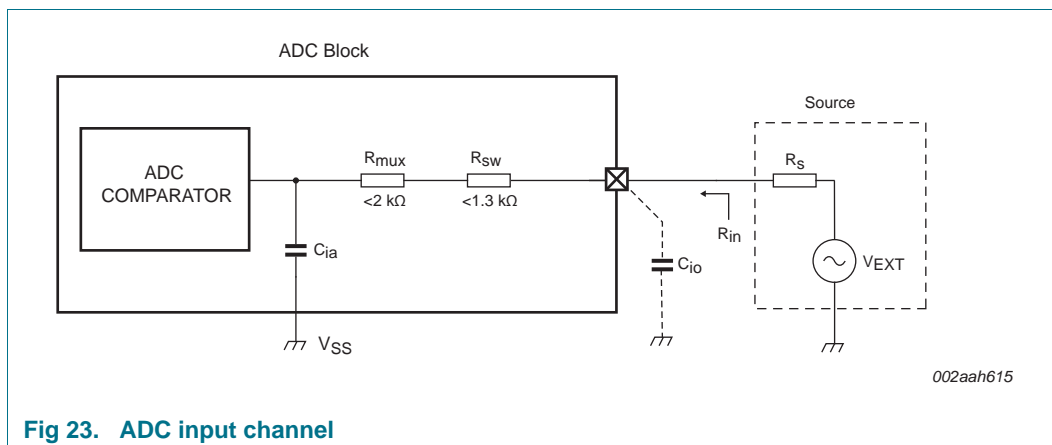


Fig 22. Reset pad configuration

## 11.5 ADC effective input impedance

A simplified diagram of the ADC input channels can be used to determine the effective input impedance seen from an external voltage source. See [Figure 23](#).



**Fig 23. ADC input channel**

The effective input impedance,  $R_{in}$ , seen by the external voltage source,  $V_{EXT}$ , is the parallel impedance of  $((1/f_s \times C_{ia}) + R_{mux} + R_{sw})$  and  $(1/f_s \times C_{io})$ , and can be calculated using [Equation 1](#) with

$f_s$  = sampling frequency

$C_{ia}$  = ADC analog input capacitance

$R_{mux}$  = analog mux resistance

$R_{sw}$  = switch resistance

$C_{io}$  = pin capacitance

$$R_{in} = \left( \frac{1}{f_s \times C_{ia}} + R_{mux} + R_{sw} \right) \parallel \left( \frac{1}{f_s \times C_{io}} \right) \quad (1)$$

Under nominal operating condition  $V_{DD} = 3.3$  V and with the maximum sampling frequency  $f_s = 400$  kHz, the parameters assume the following values:

$C_{ia} = 1$  pF (max)

$R_{mux} = 2$  kΩ (max)

$R_{sw} = 1.3$  kΩ (max)

$C_{io} = 7.1$  pF (max)

The effective input impedance with these parameters is  $R_{in} = 308$  kΩ.

## 12. Package outline

WLCSP16: wafer level chip-size package; 16 bumps; body 2.17 x 2.32 x 0.6 mm

LPC1102UK

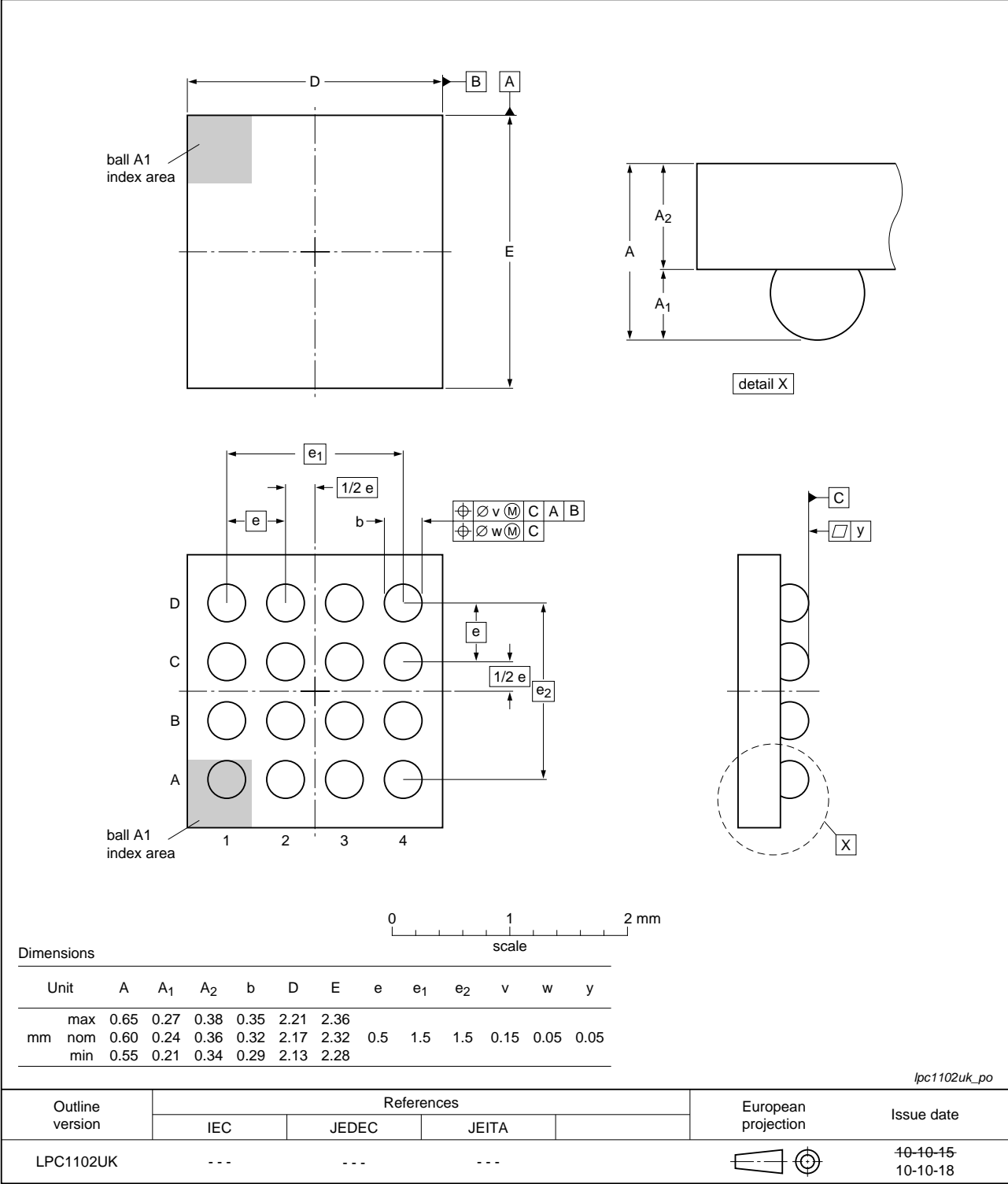


Fig 24. Package outline LPC1102UK (WLCSP16)

## 13. Abbreviations

Table 15. Abbreviations

Acronym	Description
ADC	Analog-to-Digital Converter
AHB	Advanced High-performance Bus
APB	Advanced Peripheral Bus
BOD	BrownOut Detection
GPIO	General Purpose Input/Output
PLL	Phase-Locked Loop
RC	Resistor-Capacitor
SPI	Serial Peripheral Interface
SSI	Serial Synchronous Interface
SSP	Synchronous Serial Port
UART	Universal Asynchronous Receiver/Transmitter

## 14. Revision history

Table 16. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
LPC1102_1104 v.7	20130926	Product data sheet	-	LPC1102_1104 v.6
Modifications:	<ul style="list-style-type: none"> <li>Parameter <math>V_I</math> updated in <a href="#">Table 4</a> and <a href="#">Table 5</a>. Condition <math>V_{DD} = 0</math> added.</li> <li><a href="#">Section 11.5 “ADC effective input impedance”</a> added.</li> <li>Removed <math>t_{clk(H)}</math> and <math>t_{clk(L)}</math> from <a href="#">Figure 18 “SPI master timing in SPI mode”</a> and <a href="#">Figure 19 “SPI slave timing in SPI mode”</a>; spec not characterized.</li> </ul>			
LPC1102_1104 v.6	20121231	Product data sheet	-	LPC1102_1104 v.5
Modifications:	<ul style="list-style-type: none"> <li>Added Section 9.3 “CoreMark data”.</li> <li>Conditions for power consumption in Deep-sleep mode updated in Table 5, Table note 8 and Section 9.2.</li> <li>Table 4 “Limiting values” expanded for clarity.</li> <li>BOD reset level 0 added in Table 7.</li> </ul>			
LPC1102_1104 v.5	20120727	Product data sheet	-	LPC1102 v.4
Modifications:	<ul style="list-style-type: none"> <li>Added LPC1104UK.</li> <li>Removed footnote “The peak current is limited to 25 times the corresponding maximum current.” from Table 4.</li> <li>For parameters <math>I_{OL}</math>, <math>V_{OL}</math>, <math>I_{OH}</math>, <math>V_{OH}</math>, changed conditions to <math>1.8\text{ V} \leq V_{DD} &lt; 2.5\text{ V}</math> and <math>2.5\text{ V} \leq V_{DD} \leq 3.6\text{ V}</math> in Table 5).</li> <li>WDOSc frequency range corrected.</li> <li>BOD level 0 removed in Table 7.</li> </ul>			
LPC1102 v.4	20110624	Product data sheet	-	LPC1102 v.3
Modifications:	<ul style="list-style-type: none"> <li>ADC sampling frequency corrected in Table 6 (Table note 7).</li> <li>Parameter <math>T_{cy(clk)}</math> corrected on Table 14.</li> <li>Windowed WDT features added (Section 7.13).</li> <li>Programmable open-drain mode added to GPIO pins (Section 7.7).</li> <li>Pull-up level specified in Table 3, Table note 1 and Section 7.7.</li> <li>Condition for parameter <math>T_{stg}</math> in Table 4 updated.</li> <li>Table note 4 of Table 4 updated.</li> </ul>			
LPC1102 v.3	20110418	Product data sheet	-	LPC1102 v.2
Modifications:	<ul style="list-style-type: none"> <li>Changed data sheet status to Product.</li> <li>Power consumption data added (see Figure 6 to Figure 9).</li> <li>Section 10.1 “Power-up ramp conditions” added.</li> <li>Reset pad description updated (5 V tolerant) in Table 3.</li> <li>IRC frequency data added (see Figure 16 “Internal RC oscillator frequency versus temperature”).</li> <li>Clock output removed from feature list.</li> </ul>			
LPC1102 v.2	20101126	Preliminary data sheet	-	LPC1102 v.1
Modifications:	<ul style="list-style-type: none"> <li>Changed data sheet status to Preliminary.</li> </ul>			
LPC1102 v.1	20101116	Objective data sheet	-	-



## 15. Legal information

### 15.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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